

ZL30260-ZL30263

1-APLL, 6- or 10-Output Any-to-Any Clock Multiplier and Frequency Synthesizer

Data Sheet

September 2020

Features

- **Four Flexible Input Clocks**
	- One crystal/CMOS input
	- Two differential/CMOS inputs
	- One single-ended/CMOS input
	- Any input frequency from 9.72MHz to 1.25GHz (300MHz max for CMOS)
	- Activity monitors, automatic or manual switching
	- Glitchless clock switching by pin or register
- **6 or 10 Any-Frequency, Any-Format Outputs**
	- Any output frequency from 1Hz to 1045MHz
	- High-resolution frac-N APLL with 0ppm error
	- **The APLL has a fractional divider and an integer divider to make two independent frequency families**
	- Output jitter from integer multiply and dividers as low as 0.17ps RMS (12kHz-20MHz)
	- Output jitter from fractional dividers is typically < 1ps RMS, many frequencies <0.5ps RMS
	- Each output has an independent divider
	- Each output configurable as LVDS, LVPECL, HCSL, 2xCMOS or HSTL
	- In 2xCMOS mode, the P and N pins can be different frequencies (e.g. 125MHz and 25MHz)
	- Multiple output supply voltage banks with CMOS output voltages from 1.5V to 3.3V
	- Precise output alignment circuitry and peroutput phase adjustment

-40C to +85C

• Per-output enable/disable and glitchless start/stop (stop high or low)

• **General Features**

- Automatic self-configuration at power-up from external (ZL30260 or 2) or internal (ZL30261 or 3) EEPROM; up to 8 configurations pin-selectable
- External feedback for zero-delay applications
- Numerically controlled oscillator mode
- Spread-spectrum modulation mode
- Generates PCIe 1, 2, 3, 4 compliant clocks
- Easy-to-configure design requires no external VCXO or loop filter components
- SPI or I²C processor Interface
- Core supply voltage options: 2.5V only, 3.3V only, 1.8V+2.5V or 1.8V+3.3V
- Space-saving 8x8mm QFN56 (0.5mm pitch)

Applications

• Frequency conversion and frequency synthesis in a wide variety of equipment types

Figure 1 - Functional Block Diagram

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2. Detailed Features

2.1 Input Clock Features

- Four input clocks: one crystal/CMOS, two differential/CMOS, one single-ended/CMOS
- Input clocks can be any frequency from 9.72MHz to 1250MHz (differential) or 300MHz (single-ended)
- Supported telecom frequencies include PDH, SDH, Synchronous Ethernet, OTN, wireless
- Activity monitor and glitchless input switching

2.2 APLL Features

- Very high-resolution fractional (i.e. non-integer) frequency multiplication
- Any-to-any frequency conversion with 0ppm error
- Two APLL output dividers: one integer divider (4 to 15 plus half divides 4.5 to 7.5) and one fractional
- Easy-to-configure, completely encapsulated design requires no external VCXO or loop filter
- Bypass mode supports system testing

2.3 Output Clock Features

- Six (ZL30260 or ZL30261) or ten (ZL30262 or ZL30263) low-jitter output clocks
- Each output can be one differential output or two CMOS outputs
- Output clocks can be any frequency from 1Hz to 1045MHz (250MHz max for HCSL, CMOS and HSTL)
- Output jitter from integer multiply and integer dividers as low as 0.17ps RMS (12kHz to 20MHz)
- Output jitter from fractional dividers is typically <1ps RMS, many frequencies <0.5ps RMS (12kHz to 20MHz)
- In CMOS mode, the OCxP and OCxN pins can be different divisors (Example 1: OC3P 125MHz, OC3N 25MHz; Example 2: OC3P 25MHz, OC3N 1Hz/1PPS)
- Outputs directly interface (DC coupled) with LVDS, LVPECL, HSTL, HCSL and CMOS components
- Supported telecom frequencies include PDH, SDH, Synchronous Ethernet, OTN
- Can produce clock frequencies for microprocessors, ASICs, FPGAs and other components
- Can produce PCIe-compliant clocks (PCIe 1, 2, 3 and 4)
- Sophisticated output-to-output phase alignment
- Per-output phase adjustment
- Per-output enable/disable
- Per-output glitchless start/stop (stop high or low)

2.4 General Features

- SPI or I²C serial microprocessor interface
- Automatic self-configuration at power-up; pin control to specify one of 8 stored configurations ZL30260 and ZL30262: preset configurations in ROM or user configurations in external EEPROM ZL30261 and ZL30263: user configurations in internal EEPROM
- Numerically controlled oscillator (NCO) mode allows system software to steer DPLL frequency with resolution better than 0.01ppb (1ppt can be achieved with fractional output divider value >14.56)
- Spread-spectrum modulation mode (meets PCI Express requirements)
- Zero-delay buffer configuration using an external feedback path
- Four general-purpose I/O pins each with many possible status and control options
- Reference can be fundamental-mode crystal, low-cost XO or clock signal from elsewhere in the system

2.5 Evaluation Software

- Simple, intuitive Windows-based graphical user interface
- Supports all device features and register fields
- Makes lab evaluation of the ZL30260/5/6/7 quick and easy
- Generates configuration scripts to be stored in external (ZL30260,2) or internal (ZL30261,3) EEPROM
- Generates full or partial configuration scripts to be run on a system processor
- Works with or without an evaluation board

3. Pin Diagram

The device is packaged in a 8x8mm 56-pin QFN.

Figure 3 - Pin Diagram

4. Pin Descriptions

All device inputs and outputs are LVCMOS unless described otherwise. The Type column uses the following symbols: I – input, O – output, A – analog, P – power supply pin. All GPIO and SPI/I ²C interface pins have Schmitttrigger inputs and have output drivers that can be disabled (high impedance).

Important Note: The voltages on VDDL, VDDIO, and all VDDOx pins must not exceed VDDH. Not complying with this requirement may damage the device.

5. Functional Description

5.1 Device Identification

The 12-bit read-only ID field and the 4-bit revision field are found in the [ID1](#page-42-1) and [ID2](#page-42-2) registers. Contact the factory to interpret the revision value and determine the latest revision.

5.2 Pin-Controlled Automatic Configuration at Reset

The device configuration is determined at reset (i.e. on the rising edge of RSTN) by the signal levels on these device pins: TEST/GPIO3, AC2/GPIO2, AC1/GPIO1, AC0/GPIO0, IF1/MISO and IF0/CSN. For these pins, the first name (TEST, AC2, AC1, AC0, IF1, IF0) indicates their function when they are sampled by the rising edge of the RSTN pin. The second name refers to their function after reset. The values of these pins are latched into the [CFGSR](#page-43-1) register when RSTN goes high. To ensure the device properly samples the reset values of these pins, the following guidelines should be followed:

- 1. Any pullup or pulldown resistors used to set the value of these pins at reset should be $1k\Omega$.
- 2. RSTN must be asserted at least as long as specified in section [5.9.](#page-27-0)

The hardware configuration pins are grouped into three sets:

- 1. TEST Manufacturing test mode
- 2. IF[1:0] Microprocessor interface mode and I²C address
- 3. AC[2:0] Auto-config configuration number (0 to 7)

The TEST pin selects manufacturing test modes when TEST=1 (the AC[2:0] pins specify the test mode). For ZL30261 and ZL30263 (devices with internal EEPROM), TEST=1, AC[2:0]=000, IF[1:0]=11 configures the part so that production SPI EEPROM programmers can program the internal EEPROM (see section [5.11.2\)](#page-28-1). TEST=1 and AC[2:0]=011 causes the part to start normally except it does not auto-configure from EEPROM or ROM. For more information about auto-configuration from EEPROM or ROM see section [5.11.](#page-27-3)

For all of these pins Microsemi recommends that board designs include component sites for both pullup and pulldown resistors (only one or the other populated per pin).

5.2.1 ZL30260 and ZL30262—Internal ROM, External or No EEPROM

For these part numbers the IF[1:0] pins specify the processor interface mode, the I²C slave address and whether the device should auto-configure from internal ROM or external EEPROM. The AC[2:0] pins specify which device configuration in the ROM or EEPROM to execute after reset. Descriptions of the standard-product ROM configurations are available from Microsemi.

To configure the device as specified in the first three rows above but *without* auto-configuring from internal ROM, wire devices pins as follows: $TEST=1$ and $AC[2:0]=011$, as described in sectio[n 5.2.](#page-8-2)

Notes about the device auto-configuring from external EEPROM:

- 1. The device's CSN pin should have a pull-up resistor to VDD to ensure its processor interface is inactive after auto-configuration is complete. The SCLK, MISO and MOSI pins should also have pull-up resistors to VDD to keep them from floating.
- 2. If a processor or similar device will access device registers after the device has auto-configured from external EEPROM, the SPI SCLK, MOSI and MISO wires can be connected directly to the processor, the device and the external EEPROM. The processor and device CSN pins can be wired together also. The EEPROM CSN signal must be controlled by the device's CSN pin during device auto-configuration and then held inactive when the processor accesses device registers.
- 3. The bits of the I²C address are as shown above by default but can be changed in the [I2CA](#page-42-3) register.

5.2.2 ZL30261 and ZL30263—Internal EEPROM

For these part numbers the IF[1:0] pins specify the processor interface mode and the I²C slave address. The AC[2:0] pins specify which device configuration in the EEPROM to execute after reset.

Note: the bits of the I²C address are as shown above by default but can be changed in the [I2CA](#page-42-3) register. A device's I²C slave address can be set to any value during auto-configuration at power-up by writing the [I2CA](#page-42-3) register as part of the configuration script.

5.3 Local Oscillator or Crystal

Section [5.3.1](#page-10-1) describes how to connect an external oscillator and the required characteristics of the oscillator. Section [5.3.2](#page-10-2) describes how to connect an external crystal to the on-chip crystal driver circuit and the required characteristics of the crystal. The device does not require an external oscillator or crystal for operation.

5.3.1 External Oscillator

A signal from an external oscillator can be connected to the XA pin (XB must be left unconnected).

[Table 8](#page-77-1) specifies the range of possible frequencies for the XA input. To minimize jitter, the signal must be properly terminated and must have very short trace length. A poorly terminated single-ended signal can greatly increase output jitter, and long single-ended trace lengths are more susceptible to noise. When [MCR2.](#page-36-0)XAB=10, XA is enabled as a single-ended input.

While the stability of the external oscillator can be important, its absolute frequency accuracy is less important because any known frequency inaccuracy of the oscillator can be compensated by adjusting the APLL's fractional feedback divider value [\(AFBDIV\)](#page-54-0) by ppb or ppm.

The jitter on output clock signals depends on the phase noise and frequency of the external oscillator. For the device to operate with the lowest possible output jitter, the external oscillator should have the following characteristics:

- Phase Jitter: less than 0.1ps RMS over the 12kHz to 5MHz integration band
- Frequency: The higher the better, all else being equal

5.3.2 External Crystal and On-Chip Driver Circuit

The on-chip crystal driver circuit is designed to work with a fundamental mode, AT-cut crystal resonator. See Table [2](#page-11-1) for recommended crystal specifications. To enable the crystal driver, set [MCR2.](#page-36-0)XAB=01.

Figure 4 - Crystal Equivalent Circuit / Recommended Crystal Circuit

See [Figure 4](#page-10-3) for the crystal equivalent circuit and the recommended external component connections. The driver circuit design includes configurable internal load capacitors. For a 10pF crystal the total capacitance on each of XA and XB should be 2 x 10pF = 20pF. To achieve these loads without external capacitors, register field [XACR3.](#page-75-0)XACAP should be set to 20pF minus actual XA external board trace capacitance minus XA's minimum internal capacitance of 6pF. For example, if external trace capacitance is 2pF then XACAP should be set to 20pF – 2pF – 6pF = 12pF. Register field [XACR3.](#page-75-0)XBCAP should be set in a similar manner for XB load capacitance. Crystals with nominal load capacitance other than 10pF usually can be supported with only internal load

capacitance. If the XACAP and XBCAP fields do not have sufficient range for the application, capacitance can be increased by using external caps C1 and C2.

Users should also note that on-chip capacitors are not nearly as accurate as discrete capacitors (which can have 1% accuracy). If tight frequency accuracy is required for the crystal driver circuit then set XACAP and XBCAP both to 0 and choose appropriate C1 and C2 capacitors with 1% tolerance.

The crystal, traces, and two external capacitors sites (if included) should be placed on the board as close as possible to the XA and XB pins to reduce crosstalk of active signals into the oscillator. Also no active signals should be routed under the crystal circuitry.

Note: Crystals have temperature sensitivies that can cause frequency changes in response to ambient temperature changes. In applications where significant temperature changes are expected near the crystal, it is recommended that the crystal be covered with a thermal cap, or an external XO or TCXO should be used instead.

Table 2 - Crystal Selection Parameters

Note 1: Higher frequencies give lower output jitter, all else being equal.

Note 2: These ESR limits are chosen to constrain crystal drive level to less than 100uW. If the crystal can tolerate a drive level greater than 100µW then proportionally higher ESR is acceptable.

Note 3: For crystals with 100µW max drive level: (a) f_{OSC} >55MHz and C_L>12pF is not supported, and (b) f_{OSC} >45MHz and C_L>16pF is not supported. Crystals with max drive level of 200µW or higher do not have these limitations.

Any known frequency inaccuracy of the crystal can be compensated in the APLL by adjusting the APLL's fractional feedback divider value [\(AFBDIV\)](#page-54-0) by ppb or ppm to compensate for crystal frequency error.

5.3.3 Clock Doublers

[Figure 1](#page-0-0) shows an optional clock doubler ("x2" block) following the crystal driver block. The doubler, which is enabled by setting [MCR2.](#page-36-0)DBL=1, can be used to double the frequency of the internal crystal driver circuit or a 20MHz to 78.125MHz clock signal on the XA pin. For input clock frequencies from 25MHz to 78.125MHz the duty cycle of the signal can be anywhere in the 40% to 60% range. For input clock frequencies from 20MHz to 25MHz the duty cycle must be in the 45% to 55% range. [Figure 1](#page-0-0) also shows an optional doubler at the input of the APLL. This APLL input doubler, which is enabled by setting [ACR1.](#page-51-1)INDBL=1, can be used to double the frequency of any of the inputs. The following table shows scenarios when the clock doubler can be used.

Note 1: For APLL integer multiplication, use of the doubler is application-dependent. On the positive side, use of the doubler reduces random jitter. On the negative side, the doubler causes a spur at the XA frequency (but this spur may be outside the band of interest for the application).

Note 2: The signal generated by the doubler has a very narrow and variable pulse width and therefore it is not recommended to connect the doubler signal directly to the OCx outputs using the APLL bypass path or Path 2. The doubler signal is fine as an input to the APLL, which filters the duty cycle distortion and produces a 50% duty cycle output.

Note 3: Using both doublers in series to double the XA-doubled signal is not supported.

5.3.4 Ring Oscillator (for Auto-Configuration)

After reset the internal auto-configuration boot controller is clocked by an internal ring oscillator. After auto-configuration is complete [\(GLOBISR.](#page-45-0)BCDONE=1) the ring oscillator can be disabled by setting [MCR1.](#page-35-0)ROSCD=1. The device's processor interface is asynchronous and does not require the ring oscillator.

5.4 Input Signal Format Configuration

Input clocks IC1, IC2 and IC3 are enabled by setting the enable bits in the [ICEN](#page-37-0) register. The power consumed by a differential receiver is shown in [Table 6.](#page-76-2) The electrical specifications for these inputs are listed in [Table 9.](#page-78-2) Each input clock can be configured to accept nearly any differential signal format by using the proper set of external components (see [Figure 15\)](#page-79-0). To configure these differential inputs to accept single-ended CMOS signals, connect the single-ended signal to the ICxP pin, and connect the ICxN pin to a capacitor $(0.1\mu F)$ or $0.01\mu F$) to VSS. Each ICxP and ICxN pin is internally biased to approximately 1.3V. If an input is not used, both ICxP and ICxN pins can be left floating. Note that the IC3N pin is not present. A differential signal can be connected to IC3P by AC-coupling the POS trace to IC3P and terminating the signal on the driver side of the coupling cap.

5.5 APLL Configuration

5.5.1 APLL Input Frequency

The frequencies of all enabled input clocks (ICx and XA) associated with the APLL must divide to a common APLL phase-frequency detector (PFD) frequency from 9.72MHz to 156.25MHz. In this mode the input high-speed dividers [\(ICxCR1.](#page-75-1)HSDIV) can be used to divide the ICx frequencies by 1, 2, 4 or 8 and the XA divider [\(MCR2.](#page-36-0) XODIV2) can be used to divide the XA frequency by 1 or 2. The polarity of an ICx input signal can be inverted by setting **[ICxCR1.](#page-75-1)POL.**

5.5.2 APLL Input Monitors

Each of the APLL's four inputs—IC1, IC2, IC3 and XA—have a simple activity monitor. If the monitor counts approximately four (eight if the input clock is doubled) APLL feedback clock cycles without seeing an input clock edge, the input is declared invalid and the corresponding [ICxSR.](#page-49-0)ICV bit or [XASR.](#page-49-1)ICV bit is set to 0. The input clock is declared valid, and the corresponding [ICxSR.](#page-49-0)ICV bit or [XASR.](#page-49-1)ICV bit is set to 1, when the input clock has no missing edges in an interval specified by the corresponding [ICxCR1.](#page-75-1)VALTIME or [XACR1.](#page-74-1)VALTIME field. The [XASR](#page-49-1) and [ICxSR](#page-49-0) registers provide real-time and latched status bits indicating the state of each input.

The feedback clock to use for each input monitor is specified by the [MCR2.](#page-36-0)XAMCK and MCR2.ICxMCK bits.

5.5.3 APLL Input Selection

The APLL can lock to any of inputs IC1 through IC3, a clock signal on XA (optionally clock-doubled), or the crystal driver circuit (optionally clock-doubled) when a crystal is connected to XA and XB.

The input to the APLL can be controlled by a register field, a GPIO pin, or a simple input activity monitor. When [ACR3.](#page-52-0)EXTSW=0 and [ACR3.](#page-52-0)INMON=0, the [ACR3.](#page-52-0)APLLMUX register field controls the APLL input mux.

When [ACR3.](#page-52-0)EXTSW=1, a GPIO pin controls the APLL input mux. When the GPIO pin is low, the mux selects the input specified by [ACR3.](#page-52-0)APLLMUX. When the GPIO pin is high, the mux selects the input specified by [ACR3.](#page-52-0)ALTMUX. [ACR1.](#page-51-1)EXTSS specifies which GPIO pin controls this behavior.

When [ACR3.](#page-52-0)EXTSW=0 and ACR3.INMON=1, an input monitor (see section [5.5.2\)](#page-12-4) controls the APLL input mux. When the monitor for the input specified by [ACR3.](#page-52-0)APLLMUX says that input is valid [\(ICxSR.](#page-49-0)ICV=1 or [XASR.](#page-49-1)ICV=1), the mux selects the input specified by [ACR3.](#page-52-0)APLLMUX otherwise the mux selects the input specified by **ACR3.ALTMUX.**

The [APLLSR.](#page-47-0)SELREF real-time status field indicates the APLL's selected reference.

5.5.4 APLL Output Frequency

Figure 5 - APLL Block Diagram

The APLL is enabled when [PLLEN.](#page-37-1)APLLEN=1. The APLL has a fractional-N architecture and therefore can produce output frequencies that are either integer or non-integer multiples of the input clock frequency. [Figure 5](#page-13-0) shows a block diagram of the APLL, which is built around an ultra-low-jitter multi-GHz VCO. Register fields [AFBDIV,](#page-54-0) [AFBREM,](#page-57-0) [AFBDEN](#page-56-0) and [AFBBP](#page-58-0) configure the frequency multiplication ratio of the APLL. The [ACR2.](#page-52-1)INTDIV field specifies how the VCO frequency is divided down by the APLL's integer divider (which can also do some half divides). Dividing by 6 is the typical setting to produce 622.08MHz for SDH/SONET or 625MHz for Ethernet applications. The configuration registers for the APLL's fractional divider are described in section [5.5.5.](#page-14-0)

Internally, the exact APLL feedback divider value is expressed in the form [AFBDIV](#page-54-0) + [AFBREM](#page-57-0) / [AFBDEN](#page-56-0) * 2^{-(33[-AFBBP\)](#page-58-0)}. This feedback divider value must be chosen such that APLL_input_frequency * feedback_divider_value is in the operating range of the VCO (as specified in [Table 14\)](#page-81-1). The [AFBDIV](#page-54-0) term is a fixed-point number with 9 integer bits and a configurable number of fractional bits (up to 33, as specified by [AFBBP\)](#page-58-0). Typically [AFBBP](#page-58-0) is set to 9 to specify that [AFBDIV](#page-54-0) has $33 - 9 = 24$ fractional bits. Using more than 24 fractional bits does not yield a detectable benefit. Using less than 12 fractional bits is not recommended.

The following equations show how to calculate the feedback divider values for the situation where the APLL should multiply the APLL input frequency by integer M and also fractionally scale by the ratio of integers N / D. In other words, VCO_frequency = input_frequency * M * N / D. An example of this is multiplying 77.76MHz by M=48 and scaling by $N / D = 255 / 237$ for forward error correction applications.

The trunc() function returns only the integer portion of the number. The round() function rounds the number to the nearest integer. In Equation (1), the temporary variable 'afbdiv' is set to the full-precision feedback divider value, M * N / D, truncated after the 24th fractional bit. In Equation (2) the temporary variable 'lsb_fraction' is the fraction that was truncated in Equation (1) and therefore is not represented in the afbdiv value. In Equation (3), [AFBDEN](#page-56-0) is set to the denominator of the original M * N / D ratio. In Equation (4), [AFBREM](#page-57-0) is calculated as the integer numerator of a fraction (with denominator [AFBDEN\)](#page-56-0) that equals the 'lsb_fraction' temporary variable. In Equation (5) [AFBBP](#page-58-0) is set to 33 – 24 = 9 to correspond with [AFBDIV](#page-54-0) having 24 fractional bits. Finally, in equation (6) the afbdiv bits are shifted into the proper position for the [AFBDIV](#page-54-0) registers.

When a fractional scaling scenario involves multiplying an integer M times multiple scaling ratios N_1/D_1 through N_n / D_n , the equations above can still be used if the numerators are multiplied together to get $N = N_1 \times N_2 \times ... \times N_n$ and the denominators are multiplied together to get $D = D_1 \times D_2 \times ... \times D_n$.

The easiest way to calculate the exact values to write to the APLL registers is to use the ZL3026x evaluation software, available on the Microsemi website. This software can be used even when no evaluation board is attached to the computer.

Note: After the APLL's feedback divider settings are configured in register fields [AFBDIV,](#page-54-0) [AFBREM,](#page-57-0) [AFBDEN](#page-56-0) and [AFBBP,](#page-58-0) the APLL enable bit [PLLEN.](#page-37-1)APLLEN should be changed from 0 to 1 to cause the APLL to reacquire lock with the new settings. The real-time lock/unlock status of the APLL is indicated by [APLLSR.](#page-47-0)ALK.

5.5.5 Fractional Output Divider

As shown in [Figure 1](#page-0-0) and [Figure 5,](#page-13-0) the APLL has a fractional output divider. This allows the APLL to be the source of two unrelated frequency families, one from the integer divider, and one from the fractional divider.

Configuration of the fractional output divider is very similar to configuration of the APLL's feedback divider. The fractional divider is enabled by setting [ACR1.](#page-51-1)ENFDIV. Internally, the exact divider value is expressed in the form [FDIV](#page-61-0) + [FREM](#page-64-0) / [FDEN](#page-63-0) * 2^{-(3[6-FBP\)](#page-65-1)}. The input clock to the fractional divider is APLL VCO frequency divided by 2 $(f_{VCO}/2)$. The [FDIV](#page-61-0) term is a fixed-point number with 4 integer bits and a configurable number of fractional bits (up to 36, as specified by [FBP\)](#page-65-1). Typically [FBP](#page-65-1) is set to 12 to specify that [FDIV](#page-61-0) has $36 - 12 = 24$ fractional bits.

The output clock from the fractional divider has good phase noise on rising edges but worse phase noise on falling edges and can have non-50% duty cycle. Applications that only use clock rising edges can use the fractional divider's output clock directly. For applications that care about 50% duty cycle and/or the phase noise of both rising edges and falling edges, the fractional divider should be followed by an even medium-speed divider value (2, 4, 6, 8…). The low-speed divider can be used to further divide the output clock if needed.

The maximum output frequency for the fractional divider is $f_{\text{VCO}}/10$. This means the minimum fractional divider value is 5.0. Including the need for a divide-by-2 in the medium-speed divider, the maximum frequency for a 50% duty-cycle output clock signal is $f_{VCO}/20$. The minimum output frequency for the fractional divider is $f_{VCO}/32$ since the internal [FDIV](#page-61-0) value has 4 integer bits. The combination [FDIV=](#page-61-0)0, [FREM=](#page-64-0)0, [FDEN=](#page-63-0)1 specifies to divide by 16.0. The medium-speed and low-speed dividers can be configured to follow the fractional output divider to create output frequencies down to <1Hz.

The following equations show how to calculate the register values for the situation where the fractional divider should divide by the integer M and the ratio of integers N / D. In other words,

$$
frac_div_output_freq = (VCO_freq / 2) / (M * N / D)
$$

An example of this is starting with VCO freg = 3750MHz (to get low-jitter Ethernet frequencies through the APLL's integer divider) and using the APLL's fractional divider to get 155.52MHz for SONET/SDH applications. In this example, M=12, N=15625, D=15552 are appropriate values to get 155.52MHz.

The trunc() function returns only the integer portion of the number. The round() function rounds the number to the nearest integer. In Equation (1), the temporary variable 'fdiv' is the full-precision feedback divider value, M * N / D, truncated after the 24th fractional bit. In Equation (2) the temporary variable 'lsb_fraction' is the fraction that was truncated in Equation (1) and therefore is not represented in the fdiv value. In Equation (3), [FDEN](#page-63-0) is set to the denominator of the original M * N / D ratio. In Equation (4), [FREM](#page-64-0) is calculated as the integer numerator of a

fraction (with denominator [FDEN\)](#page-63-0) that equals the 'lsb_fraction' temporary variable. In Equation (5) [FBP](#page-65-1) is set to 36 – 24 =12 to correspond with [FDIV](#page-61-0) having 24 fractional bits. Finally, in equation (6) the fdiv bits are shifted into the proper position for the [FDIV](#page-61-0) registers.

When a fractional scaling scenario involves multiplying an integer M times multiple scaling ratios N_1/D_1 through N_n / D_n , the equations above can still be used if the numerators are multiplied together to get $N = N_1 \times N_2 \times ... \times N_n$ and the denominators are multiplied together to get $D = D_1 \times D_2 \times ... \times D_n$.

The easiest way to calculate the exact values to write to the APLL's fractional output divider registers is to use the ZL3026x evaluation software, available on the Microsemi website. This software can be used even when no evaluation board is attached to the computer.

5.5.6 Numerically Controlled Oscillator (NCO) Mode

5.5.6.1 Using the APLL's Feedback Divider

System software can steer output frequencies with high resolution by manipulating the APLL's [AFBDIV](#page-54-0) value. The resolution can be better than 0.01ppb.

The nominal [AFBDIV](#page-54-0) value, hereafter referred to as AFBDIV0, is the 0ppm nominal value for the desired device configuration.

(Fractional frequency offset (FFO) is defined as (actual_frequency – nominal_frequency) / nominal_frequency. FFO is a unitless number but is typically expressed in parts per billion (ppb), parts per million (ppm) or percent.)

To control the NCO, system software first reads the AFBDIV0 value from the device. Even though the [AFBDIV](#page-54-0) register description describes AFBDIV as having 9 integer bits and 33 fractional bits, for the NCO calculations that follow, AFBDIV values should be treated as 42-bit unsigned integers.

To change the NCO frequency to a specific FFO (in ppm), system software calculates newAFBDIV (a 42-bit unsigned integer) as follows:

 $newAFBDIV = round(AFBDIVO * (1 + FFO/1e6))$

System software then writes the newAFBDIV value directly to the [AFBDIV](#page-54-0) registers.

Note that any subsequent frequency changes are calculated using the same equation from the original AFBDIV0 value and are not a function of the previous newAFBDIV value. The value of newAFBDIV should be kept within ±1000ppm of AFBDIV0 and within ±500ppm of the previous newAFBDIV value to avoid causing the APLL to lose lock. If spread spectrum modulation is also in use, the total frequency change caused by spread spectrum modulation and NCO control should be kept within ±5000ppm of AFBDIV0 to avoid causing the APLL to lose lock.

During NCO operation using the APLL's feedback divider, [AFBREM](#page-57-0) should be set to 0, [AFBDEN](#page-56-0) should be set to 1 and [AFBBP](#page-58-0) should be set to 0.

5.5.6.2 Using the Fractional Output Divider

System software can steer output frequencies derived from the fractional output divider with high resolution by manipulating the divider's [FDIV](#page-61-0) value. The resolution can be better than 0.01ppb. In the case of fractional output divider value >14.55192, the resolution is better than 1ppt.

The nominal [FDIV](#page-61-0) value, hereafter referred to as FDIV0, is the 0ppm nominal value for the desired device configuration.

(Fractional frequency offset (FFO) is defined as (actual_frequency – nominal_frequency) / nominal_frequency. FFO is a unitless number but is typically expressed in parts per billion (ppb), parts per million (ppm) or percent.)

To control the NCO, system software first reads the [FDIV](#page-61-0)0 value from the device. Even though the FDIV register description describes FDIV as having 4 integer bits and 36 fractional bits, for the NCO calculations that follow, FDIV values should be treated as 40-bit unsigned integers.

To change the NCO frequency to a specific FFO (in ppm), system software calculates newFDIV (a 40-bit unsigned integer) as follows:

 $newFDIV = round(FDIV0 / (1 + FFO/1e6))$

System software then writes the newFDIV value directly to the [FDIV](#page-61-0) registers.

Note that any subsequent frequency changes are calculated using the same equation from the original FDIV0 value and are not a function of the previous newFDIV value.

During NCO operation using the fractional output divider, [FREM](#page-64-0) should be set to 0, [FDEN](#page-63-0) should be set to 1 and [FBP](#page-65-1) should be set to 0.

5.5.7 Frequency Increment and Decrement

When [ACR1.](#page-51-1)USEFDIV=0 the APLL's feedback divider value can be incremented or decremented by values ranging from approximately 1ppb to 500ppm. The value [AID\[](#page-60-0)23:0] x 2⁷ is added to the APLL's feedback divider value each time the trigger specified by [AIDCR.](#page-58-1)FISS changes state. [AID\[](#page-60-0)23:0] x 2⁷ is subtracted from the APLL's feedback divider value each time the trigger specified by [AIDCR.](#page-58-1)FDSS changes state. The value to be written to [AID\[](#page-60-0)23:0] s as follows:

AID = round(AFBDIV0 $*$ FFO/1e6 / 2⁷)

where FFO is the desired fractional frequency offset (FFO) per increment or decrement step in ppm

AFBDIV0 is the nominal [AFBDIV](#page-54-0) value, obtained by reading [AFBDIV](#page-54-0) when [AFBDL.](#page-53-0)RDCUR=0

The current APLL feedback divider value (i.e. the value after increments and decrements) can be read from the [AFBDIV](#page-54-0) registers when [AFBDL.](#page-53-0)RDCUR=1. The original value of the AFBDIV registers before increments and decrements can be read from the [AFBDIV](#page-54-0) registers when [AFBDL.](#page-53-0)RDCUR=0. Incrementing and decrementing only occur when the APLL is locked [\(APLLSR.](#page-47-0)ALK=1). If the APLL loses lock, when it locks again the APLL sets its feedback divider value back to the AFBDIV0 value. The system must be designed to ensure the current feedback divider value stays within ±1000ppm of the AFBDIV0 value to avoid causing the APLL to lose lock. The maximum increment/decrement is 500ppm. Frequency increment/decrement behavior is mutually exclusive with spreadspectrum modulation (see section [5.5.8\)](#page-16-1) because both behaviors use the [AID](#page-60-0) registers. Frequency increment/decrement is enabled when [ACR1.](#page-51-1)ENFID=1. When ENFID is set to 0 the APLL feedback divider instantly changes to the AFBDIV0 value. Therefore, to avoid a frequency jump on output clocks, system software should increment or decrement back to the AFBDIV0 value before changing ENFID to 0.

5.5.8 Spread-Spectrum Modulation Mode

For EMI-sensitive applications such as PCI Express, the device can perform spread spectrum modulation (SSM). In SSM the frequency of the output clock is continually varied over a narrow frequency range to spread the energy of the signal and thereby reduce EMI. This mode is a special case of NCO mode.

Spread spectrum mode is enabled by the [ASCR.](#page-59-0)ENSS bit or by a GPIO pin as specified by [ASCR.](#page-59-0)SPRDSS.

5.5.8.1 Using the APLL's Feedback Divider

When [ACR1.](#page-51-1)USEFDIV=0 the device performs frequency modulation by modulating the APLL's feedback divider value starting from the nominal value specified in the [AFBDIV](#page-54-0) registers.

For center-spread applications [\(ASCR.](#page-59-0)DWNEN=0), the frequency modulation is triangle-wave center-spread of up to ±0.5% deviation from the center frequency with modulation rate configurable from 25kHz to 55kHz. The spread deviation and modulation rate are controlled by specifying an increment/decrement step in the [AID](#page-60-0) registers and the number of APLL input clock cycles to increment and decrement in the [ASCNT](#page-59-1) registers. The values to be written to the device are calculated as follows:

$$
ASCII = round\left(\frac{F_{IN}}{4 * F_{MOD}}\right) - 2
$$
\n
$$
AID = round\left(\frac{F_{VCO}}{F_{IN}} * \frac{S * 2^{32}}{ASCNT + 2}\right)
$$

where F_{VCO} is the APLL"s VCO frequency in Hz,

 F_{IN} is the input frequency at the APLL's PFD in Hz,

F_{MOD} is the spread-spectrum modulation frequency in Hz,

and S is the peak-to-peak spread percentage expressed as a decimal (example $\pm 0.5\% \rightarrow$ S=0.01)

For down-spread applications [\(ASCR.](#page-59-0)DWNEN=1), such as PCI Express Refclk, the frequency modulation is triangle-wave down-spread of up to -1% deviation from the nominal frequency with modulation rate configurable from 25kHz to 55kHz. The spread deviation and modulation rate are controlled by specifying an increment/decrement step in the [AID](#page-60-0) registers and the number of APLL input clock cycles to increment and decrement in the [ASCNT](#page-59-1) registers. The values to be written to the device are calculated as follows:

$$
ASCNT = round\left(\frac{F_{IN}}{2 * F_{MOD}}\right) - 2
$$

$$
AID = round\left(\frac{F_{VCO}}{F_{IN}} * \frac{S * 2^{33}}{ASCNT + 2}\right)
$$

All of the input parameters are the same as for center spread above. Note the small differences between these down-spread equations and the center-spread equations above. ASCNT here has 2 in the denominator while it has 4 for center-spread. AID has 2^{33} in the numerator for down-spread while it has 2^{32} for center-spread.

During spread-spectrum operation using the APLL's feedback divider, [AFBREM](#page-57-0) should be set to 0, [AFBDEN](#page-56-0) should be set to 1 and [AFBBP](#page-58-0) should be set to 0. Spread-spectrum modulation only occurs when the APLL is locked [\(APLLSR.](#page-47-0)ALK=1).

5.5.8.2 Using the Fractional Output Divider

When [ACR1.](#page-51-1)USEFDIV=1 the device performs frequency modulation by modulating the fractional output divider value starting from the nominal value specified in the [FDIV](#page-61-0) registers.

For center-spread applications [\(ASCR.](#page-59-0)DWNEN=0), the frequency modulation is triangle-wave center-spread of up to ±5% deviation from the center frequency with modulation rate configurable from 10kHz to 100kHz. (Values outside of these ranges are often achievable as well.) The spread deviation and modulation rate are controlled by specifying an increment/decrement step in the [AID](#page-60-0) registers and the number of APLL input clock cycles to increment and decrement in the [ASCNT](#page-59-1) registers. The [ASCR.](#page-59-0)CNTEN register field must also be set propertly. The values to be written to the device are calculated as follows:

$$
CNTEN = 0 for F_{IN} < 50 MHz
$$
\n
$$
1 for 50 MHz \leq F_{IN} < 100 MHz
$$
\n
$$
2 for F_{IN} \geq 100 MHz
$$

$$
ASCII = round\left(\frac{F_{IN}}{4 * F_{MOD} * 2^{CNTEN}}\right) - 2
$$

$$
AID = round\left(\frac{F_{VCO}}{F_{OUT}} * \frac{S * 2^{34}}{(ASCNT + 2) * (1 - 0.5S)}\right)
$$

where F_{VCO} is the APLL"s VCO frequency in Hz,

 F_{IN} is the input frequency at the APLL's PFD in Hz,

 F_{OUT} is the fractional output divider block's output frequency in Hz,

F_{MOD} is the spread-spectrum modulation frequency in Hz,

and S is the peak-to-peak spread percentage expressed as a decimal (example $\pm 0.5\% \rightarrow$ S=0.01)

For down-spread applications [\(ASCR.](#page-59-0)DWNEN=1), such as PCI Express Refclk, the frequency modulation is triangle-wave down-spread of up to -10% deviation from the nominal frequency with modulation rate configurable from 10kHz to 100kHz. (Values outside of these ranges are often achievable as well.) The spread deviation and modulation rate are controlled by specifying an increment/decrement step in the [AID](#page-60-0) registers and the number of

APLL input clock cycles to increment and decrement in the [ASCNT](#page-59-1) registers. The [ASCR.](#page-59-0)CNTEN register field must also be set propertly. The values to be written to the device are calculated as follows:

$$
CNTEN = 0 \text{ for } F_{IN} < 50MHz
$$
\n
$$
1 \text{ for } 50MHz \le F_{IN} < 100MHz
$$
\n
$$
2 \text{ for } F_{IN} \ge 100MHz
$$
\n
$$
ASCII = round\left(\frac{F_{IN}}{2 * F_{MOD} * 2^{CNTEN}}\right) - 2
$$
\n
$$
AID = round\left(\frac{F_{VCO}}{F_{OUT} * (ASCNT + 2) * (1 - 0.5S)}\right)
$$

All of the input parameters are the same as for center spread above. Note the small differences between these down-spread equations and the center-spread equations above. ASCNT here has 2 in the denominator while it has 4 for center-spread. AID has 2^{35} in the numerator for down-spread while it has 2^{34} for center-spread.

During spread-spectrum operation using the fractional output divider, [FREM](#page-64-0) should be set to 0, [FDEN](#page-63-0) should be set to 1 and [FBP](#page-65-1) should be set to 0. The [F1CR1.](#page-61-1)MODE field must be set to 1 when doing spread-spectrum modulation with the fractional output divider value. Spread-spectrum modulation only occurs when the APLL is locked [\(APLLSR.](#page-47-0)ALK=1).

5.5.9 APLL Phase Adjustment

The phase of the APLL's output clock can be incremented or decremented. When the APLL's [AFBDIV](#page-54-0) value is not an exact multiple of 0.5 then the phase adjustment step size is 1/8th of a VCO cycle. This phase step size is 30ps at maximum VCO frequency of 4180MHz and 33.7ps at minimum VCO frequency of 3715MHz. The [ACR4.](#page-53-1)PDSS field specifies the phase decrement control signal, which can be the [ACR4.](#page-53-1)DECPH bit or any of the four GPIOs. The [ACR4.](#page-53-1)PISS field specifies the phase increment control signal, which can be the [ACR4.](#page-53-1)INCPH bit or any of the four GPIOs. Phase is adjusted on every rising edge and every falling edge of the control signal. This phase adjustment affects the output of the APLL's output dividers (integer and fractional).

When the APLL's [AFBDIV](#page-54-0) value is an exact multiple of 0.5 then the phase adjustment step size is one VCO cycle.

5.6 Output Clock Configuration

The ZL30260 and ZL30261 have six output clock signal pairs while the ZL30262 and ZL30263 have ten. Each output has individual divider, enable and signal format controls. In CMOS mode each signal pair can become two CMOS outputs, allowing the device to have up to 12 or 20 output clock signals. Also in CMOS mode, the OCxN pin can have an additional divider allowing the OCxN frequency to be an integer divisor of the OCxP frequency (example: OC3P 125MHz and OC3N 25MHz). The outputs can be aligned relative to each other, and the phases of output signals can be adjusted dynamically with high resolution.

5.6.1 Output Enable, Signal Format, Voltage and Interfacing

To use an output, the output driver must be enabled by setting $OCxCR2.OCSF $\neq 0$, and the per-output dividers must$ $OCxCR2.OCSF $\neq 0$, and the per-output dividers must$ be enabled by setting the appropriate bit in the [OCEN](#page-38-0) register. The per-output dividers include the medium-speed divider, the low-speed divider and the associated phase adjustment/alignment circuitry and start/stop logic.

Using the [OCxCR2.](#page-67-1)OCSF register field, each output pair can be disabled or configured as LVDS, LVPECL, HCSL, HSTL, or one or two CMOS outputs. When an output is disabled it is high impedance, and the output driver is in a low-power state. In CMOS mode, the OCxN pin can be disabled, in-phase or inverted vs. the OCxP pin. All of these options are specified by [OCxCR2.](#page-67-1)OCSF. The clock to the output driver can inverted by setting [OCxCR2.](#page-67-1)POL=1. The CMOS/HSTL output driver can be set to any of four drive strengths using [OCxCR2.](#page-67-1)DRIVE.

When $OCxCR2.OCSF=0001$ $OCxCR2.OCSF=0001$ the output driver is in LVDS mode. V_{op} is forced to 400mV and $OCxDIFF.VOD$ is ignored. V_{CM} can be configured in [OCxDIFF.](#page-68-0)VCM, but the default value of 0000 is typically used to get $V_{CM}=1.23V$ for LVDS.

When [OCxCR2.](#page-67-1)OCSF=0010 the output driver is in programmable differential mode. In this mode the output swing (V_{OD}) can be set in [OCxDIFF.](#page-68-0) VOD and the common-mode voltage can be set in OCxDIFF. VCM. Together these

fields allow the output signal to be customized to meet the requirements of the clock receiver and minimize the need for external components. By default, when OCSF=0010 the output is configured for LVPECL signal swing with a 1.23V common mode voltage. This gives a signal that can be AC-coupled (after a 100 Ω termination resistor) to receivers that are LVPECL or that require a larger signal swing than LVDS. The output driver can also be configured for LVPECL output with standard 2.0V common-mode voltage by seting [OCxDIFF.](#page-68-0)VCM for 2.0V and setting [OCxREG.](#page-69-0) VREG appropriately.

In both LVDS mode and programmable differential mode the output driver requires a DC path through a 100 Ω resistor between OCxP and OCxN for proper operation. This resistor is usually placed as close as possible to the receiver inputs to terminate the differential signal. If the receiver requires a common-mode voltage that cannot be matched by the output driver then the POS and NEG signals can be AC-coupled to the receiver after the 100 Ω resistor.

HCSL mode requires a DC path through a 50Ω resistor to ground on each of OCxP and OCxN. Note that each of the [OCxDIFF.](#page-68-0)VCM, [OCxDIFF.](#page-68-0)VOD and [OCxREG.](#page-69-0)VREG register fields has a particular setting required for HCSL signal format. See the descriptions of these fields for details.

Outputs are grouped into six power supply banks, VDDOA through VDDOF to allow CMOS or HSTL signal swing from 1.5V to 3.3V for glueless interfacing to neighboring components. 10-output products have outputs grouped into banks in a 2-1-2-2-1-2 arrangement, as shown in [Figure 1.](#page-0-0) 6-output products have one output per bank. If OCSF is set to HSTL mode then a 1.5V power supply voltage should be used to get a standards-compliant HSTL output. Note that LVDS, LVPECL and HCSL signal formats must have a power supply of 2.5V or 3.3V. Also note that VDDO voltage must not exceed VDDH voltage.

5.6.2 Output Frequency Configuration

The frequency of each output is determined by the configuration of the APLL, the APLL's output dividers, and the per-output dividers. Each bank of outputs can be connected to the APLL's integer divider, the APLL's fractional divider, or Path 2 (see section [5.15\)](#page-29-0) using the appropriate field in the [OCMUX](#page-38-1) registers.

Each output has two output dividers, a 7-bit medium-speed divider [\(OCxCR1.](#page-67-2)MSDIV) and a 24-bit low-speed output divider (LSDIV field in the [OCxDIV](#page-71-0) registers). These dividers are in series, medium-speed divider first then output divider. These dividers produce signals with 50% duty cycle for all divider values including odd numbers. The low-speed divider can only be used if the medium-speed divider is used (i.e. [OCxCR1.](#page-67-2)MSDIV>0). The maxium input frequency to the medium-speed divider is 750MHz.

Since each output has its own independent dividers, the device can output families of related frequencies that have an APLL output frequency as a common multiple. For example, for Ethernet clocks, a 625MHz APLL output clock can be divided by four for one output to get 156.25MHz, divided by five for another output to get 125MHz, and divided by 25 for another output to get 25MHz. Similarly, for SDH/SONET clocks, a 622.08MHz APLL output clock can be divided by 4 to get 155.52MHz, by 8 to get 77.76MHz, by 16 to get 38.88MHz or by 32 to get 19.44MHz.

Two Different Frequencies in 2xCMOS Mode

When an output is in 2xCMOS mode it can be configured to have the frequency of the OCxN clock be an integer divisor of the frequency of the OCxP clock. Examples of where this can be useful:

- 125MHz on OCxP and 25MHz on OCxN for Ethernet applications
- 77.76MHz on OCxP and 19.44MHz on OCxN for SONET/SDH applications
- 25MHz on OCxP and 1Hz (i.e. 1PPS) on OCxN for telecom applications with Synchronous Ethernet and IEEE1588 timing

An output can be configured to operate like this by setting the LSDIV value in the $OCxDU$ registers to $OCxP$ freq / OCxN_freq - 1 and setting [OCxCR3.](#page-70-0)LSSEL=0 and [OCxCR3.](#page-70-0)NEGLSD=1. Here are some notes about this dualfrequency configuration option:

• In this mode only the medium speed divider is used to create the OCxP frequency. The lowspeed divider is then used to divide the OCxP frequency down to the OCxN frequency. This means that the lowest OCxP frequency is the APLL divider output frequency divided by 128.

• An additional constraint is that the medium-speed divider must be configured to divide by 2 or more (i.e. must have $OCxCR1.MSDIV \ge 1$).

5.6.3 Output Duty Cycle Adjustment

For output frequencies less than or equal to 141.666MHz, the duty cycle of the output clock can be modified using the [OCxDC.](#page-71-1)OCDC register field. This behavior is only available when MSDIV>0 and LSDIV > 1. When OCDC = 0 the output clock is 50%. Otherwise the clock signal is a pulse with a width of OCDC number of MSDIV output clock periods. The range of OCDC can create pulse widths of 1 to 255 MSDIV output clock periods. When [OCxCR2.](#page-67-1)POL=0, the pulse is high and the signal is low the remainder of the cycle. When POL=1, the pulse is low and the signal is high the remainder of the cycle.

Note that duty cycle adjustment is done in the low-speed divider. Therefore when [OCxCR3.](#page-70-0)LSSEL=0 the duty cycle of the output is not affected. Also, when a CMOS output is configured with [OCxCR3.](#page-70-0)LSSEL=0 and [OCxCR3.](#page-70-0)NEGLSD=1, the OCxN pin has duty cycle adjustment but the OCxP pin does not. This allows a higherspeed 50% duty cycle clock signal to be output on the OCxP pin and a lower-speed frame/phase/time pulse (e.g. 2kHz, 8kHz or 1PPS) to be output on the OCxN pin at the same time.

An output configured for CMOS or HSTL signal format should not be configured to have a duty cycle with high time shorter than 2ns or low time shorter than 2ns.

5.6.4 Output Phase Adjustment

The phase of an output signal can be shifted by 180 $^{\circ}$ by setting [OCxCR2.](#page-67-1)POL=1. In addition, the phase can be adjusted using the [OCxPH.](#page-72-0)PHADJ register field. The adjustment is in units of bank source clock cycles. For example, if the bank source clock is 625MHz (from the APLL for example) then one bank source clock cycle is 1.6ns, the smallest phase adjustment is 0.8ns, and the adjustment range is \pm 5.6ns.

5.6.5 Output-to-Output Phase Alignment

A 0-to-1 transition of the [ACR1.](#page-51-1)DALIGN bit causes a simultaneous reset of the medium-speed dividers and low-speed dividers for all output clocks following the APLL where [OCxCR1.](#page-67-2)PHEN=1. After this reset, all PHEN=1 output clocks from the same APLL divider (IntDiv or FracDiv) are rising-edge aligned, with the phase of each output clock signal adjusted as specified by its [OCxPH.](#page-72-0)PHADJ register field. Alignment of clocks from IntDiv with clocks from FracDiv is not supported. Similarly a 0-to-1 transition of the [P2CR1.](#page-65-2)DALIGN bit aligns all output clocks following Path 2 where [OCxCR1.](#page-67-2)PHEN=1. Alignment is not glitchess; i.e. it may cause a short high time or low time on participating output clock signals. A glitchless alignment can be accomplished by first stopping the clocks, then aligning them, then starting them. Output clock start and stop is described in section [5.6.7.](#page-20-4)

5.6.6 Output-to-Input Phase Alignment

The best approach for achieving output-to-input phase alignment is to use external feedback in which an OCx output is connected to an ICx input. To enable external feedback, set [AFBDL.](#page-53-0)EXTFB=1, set AFBDL.FBSEL to specify the external feedback path, and provide the associated output-to-input wiring on the PCB. In this configuration the APLL, in a closed-loop manner, automatically phase-aligns all OCx outputs from the APLL to the APLL's selected reference. Any small error in this alignment due to wire delays can be compensated in the outputs' phase adjustment registers, [OCxPH.](#page-72-0)PHADJ.

5.6.7 Output Clock Start and Stop

Output clocks can be stopped high or low or high-impedance. One use for this behavior is to ensure "glitchless" output clock operation while the output is reconfigured or phase aligned with some other signal.

Each output has an [OCxSTOP](#page-72-1) register with fields to control this behavior. The [OCxSTOP.](#page-72-1)MODE field specifies whether the output clock signal stops high, low, or high-impedance. The [OCxSTOP.](#page-72-1)SRC field specifies the source of the stop signal. Options include control bits or one of the GPIO pins. When [OCxSTOP.](#page-72-1)SRC=0001 the output clock is stopped when the corresponding bit is set in the [STOPCR](#page-39-0) registers OR the [MCR1.](#page-35-0)STOP bit is set.

When the stop mode is Stop High [\(OCxSTOP.](#page-72-1)MODE= $x1$) and the stop signal is asserted, the output clock is stopped after the next rising edge of the output clock. When the stop mode is Stop Low (OCxSTOP MODE=x0) and the stop signal is asserted, the output clock is stopped after the next falling edge of the output clock. When the output is stopped, the output driver can optionally go high-impedance [\(OCxSTOP.](#page-72-1)MODE=1x). Internally the clock

signal continues to toggle while the output is stopped. When the stop signal is deasserted, the output clock resumes on the opposite edge that it stopped on. Low-speed output clocks can take long intervals before being stopped after the stop signal goes active. For example, a 1 Hz output could take up to 1 second to stop.

When [OCxCR2.](#page-67-1)POL=1 the output stops on the opposite polarity that is specified by the [OCxSTOP.](#page-72-1)MODE field.

Generally [OCxCR1.](#page-67-2)MSDIV must be > 0 for this function to operate correctly since MSDIV=0 bypasses the startstop circuits.

When MSDIV=0, [OCxSTOP.](#page-72-1)MODE=11 (stop high then go high-impedance) can be used to make outputs highimpedance, but the action won't necessarily be glitchless. To use this behavior to get "stop *low* then go-impedance" behavior, [OCxCR2.](#page-67-1)POL can be set to 1.

Note that when [OCxCR3.](#page-70-0)NEGLSD=1 the start-stop logic is bypassed for the OCxN pin, and OCxN may not start/stop without glitches.

Each output has a status register [\(OCxSR\)](#page-50-0) with several stop/start status bits. The STOPD bit is a real-time status bit indicating stopped or not stopped. The STOPL bit is a latched status bit that is set when the output clock has stopped. The STARTL bit is a latched status bit that is set when the output clock has started.

5.7 Microprocessor Interface

The device can communicate over a SPI interface or an I²C interface.

In SPI mode ZL3026x devices without internal EEPROM can be configured at reset to be a SPI slave to a processor master or a SPI master to an external EEPROM slave. (SPI master operation changes to SPI slave operation after auto-configuration from the external EEPROM is complete.) The ZL3026x devices with internal EEPROM can only be configured as a SPI slave to a processor master. All devices are always slaves on the I²C bus.

Section [5.2](#page-8-2) describes reset pin settings required to configure the device for these interfaces.

5.7.1 SPI Slave

The device can present a SPI slave port on the CSN, SCLK, MOSI, and MISO pins. SPI is a widely used master/slave bus protocol that allows a master and one or more slaves to communicate over a serial bus. SPI masters are typically microprocessors, ASICs or FPGAs. Data transfers are always initiated by the master, which also generates the SCLK signal. The device receives serial data on the MOSI (Master Out Slave In) pin and transmits serial data on the MISO (Master In Slave Out) pin. MISO is high impedance except when the device is transmitting data to the bus master.

Bit Order. The register address and all data bytes are transmitted most significant bit first on both MOSI and MISO.

Clock Polarity and Phase. The device latches data on MOSI on the rising edge of SCLK and updates data on MISO on the falling edge of SCLK. SCLK does not have to toggle between accesses, i.e., when CSN is high.

Device Selection. Each SPI device has its own chip-select line. To select the device, the bus master drives its CSN pin low.

Command and Address. After driving CSN low, the bus master transmits an 8-bit command followed by a 16-bit register address. The available commands are shown below.

Table 3 - SPI Commands

Read Transactions. The device registers are accessible when [EESEL=](#page-33-2)0. On ZL3026x devices with internal EEPROM, the EEPROM memory is accessible when the [EESEL](#page-33-2) bit is 1. On ZL3026x devices without internal EEROM, the [EESEL](#page-33-2) bit must be set to 0. After driving CSN low, the bus master transmits the read command followed by the 16-bit address. The device then responds with the requested data byte on MISO, increments its address counter, and prefetches the next data byte. If the bus master continues to demand data, the device continues to provide the data on MISO, increment its address counter, and prefetch the following byte. The read transaction is completed when the bus master drives CSN high. See [Figure 6.](#page-22-0)

Register Write Transactions. The device registers are accessible when [EESEL=](#page-33-2)0. After driving CSN low, the bus master transmits the write command followed by the 16-bit register address followed by the first data byte to be written. The device receives the first data byte on MOSI, writes it to the specified register, increments its internal address register, and prepares to receive the next data byte. If the master continues to transmit, the device continues to write the data received and increment its address counter. The write transaction is completed when the bus master drives CSN high. See [Figure 8.](#page-23-2)

EEPROM Writes (ZL30261, ZL30263 Only). The internal EEPROM memory is accessible when the [EESEL](#page-33-2) bit is 1. After driving CSN low, the bus master transmits the write enable command and then drives CSN high to set the internal write enable latch. The bus master then drives CSN low again and transmits the write command followed by the 16-bit address followed by the first data byte to be written. The device first copies the page to be written from EEPROM to its page buffer. The device then receives the first data byte on MOSI, writes it to its page buffer, increments its internal address register, and prepares to receive the next data byte. If the master continues to transmit, the device continues to write the data received to its page buffer and continues to increment its address counter. The address counter rolls over at the 32-byte page boundary (i.e. when the five least-significant address bits are 11111). When the bus master drives CSN high, the device transfers the data in the page buffer to the appropriate page in the EEPROM memory. See [Figure 7](#page-23-1) and [Figure 8.](#page-23-2)

EEPROM Read Status (ZL30261, ZL30263 Only). After the bus master drives CSN high to end an EEPROM write command, the EEPROM memory is not accessible for up to 5ms while the data is transferred from the page buffer. To determine when this transfer is complete, the bus master can use the Read Status command. After driving CSN low, the bus master transmits the Read Status command. The device then responds with the status byte on MISO. In this byte, the least significant bit is set to 1 if the transfer is still in progress and 0 if the transfer has completed.

Early Termination of Bus Transactions. The bus master can terminate SPI bus transactions at any time by pulling CSN high. In response to early terminations, the device resets its SPI interface logic and waits for the start of the next transaction. If a register write transaction is terminated prior to the SCLK edge that latches the least significant bit of a data byte, the data byte is not written. On devices with internal EEPROM, if an EEPROM write transaction is terminated prior to the SCLK edge that latches the least significant bit of a data byte, none of the bytes in that write transaction are written.

Design Option: Wiring MOSI and MISO Together. Because communication between the bus master and the device is half-duplex, the MOSI and MISO pins can be wired together externally to reduce wire count. To support this option, the bus master must not drive the MOSI/MISO line when the device is transmitting.

AC Timing. See [Table 19](#page-84-1) and [Figure 18](#page-84-0) for AC timing specifications for the SPI interface.

Figure 6 - SPI Read Transaction Functional Timing

Figure 7 - SPI Write Enable Transaction Functional Timing (ZL30261 and ZL30263 Only)

Figure 8 - SPI Write Transaction Functional Timing

5.7.2 SPI Master (ZL30260 and ZL30262 Only)

After reset these devices can present a SPI master port on the CSN, SCLK, MOSI, and MISO pins for autoconfiguration using data read from an external SPI EEPROM. During auto-configuration the device is always the SPI master and generates the CSN and SCLK signals. The device transmits serial data on the the MOSI (Master Out Slave In) pin and receives serial data on the MISO (Master In Slave Out) pin.

Bit Order. The register address and all data bytes are transmitted most significant bit first on both MOSI and MISO.

Clock Polarity and Phase. The device latches data on MISO on the rising edge of SCLK and updates data on MOSI on the falling edge of SCLK.

Device Selection. Each SPI device has its own chip-select line. To select the external EEPROM, the device drives the CSN signal low.

Command and Address. After driving CSN low, the device transmits an 8-bit read command followed by a 16-bit register address. The read command is shown below.

Read Transactions. After driving CSN low, the device transmits the read command followed by the 16-bit register address. The external EEPROM then responds with the requested data byte on MISO, increments its address counter, and prefetches the next data byte. If the device continues to demand data, the EEPROM continues to provide the data on MISO, increment its address counter, and prefetch the following byte. The read transaction is completed when the device drives CSN high. See [Figure 6.](#page-22-0)

Writing the External EEPROM. Due to the small package size and low pin count of the device, there is no way to use the ZL30260 or ZL30262 to write the external EEPROM. The auto-configuration data used by the ZL30260 or ZL30262 must be pre-programmed into the EEPROM by some other method, such as:

1. The EEPROM manufacturer can write the data to the EEPROM during production testing. This is a service they routinely provide.

2. A contract manufacturer or distributor can write the data to the EEPROM using a production EEPROM programmer before the EEPROM is mounted to the board.

5.7.3 I ²C Slave

Microsemi

The device can present a fast-mode (400kbit/s) I²C slave port on the SCL and SDA pins. I²C is a widely used master/slave bus protocol that allows one or more masters and one or more slaves to communicate over a twowire serial bus. I²C masters are typically microprocessors, ASICs or FPGAs. Data transfers are always initiated by the master, which also generates the SCL signal. The device is compliant with version 2.1 of the I²C specification.

The I²C interface on the device is a protocol translator from external I²C transactions to internal SPI transactions. This explains the slightly increased protocol complexity described in the paragraphs that follow.

Read Transactions. The device registers are accessible when the [EESEL](#page-33-2) bit is 0. On ZL30261 and ZL30263 the internal EEPROM memory is accessible when the [EESEL](#page-33-2) bit is 1. On ZL30260 and ZL30262 the [EESEL](#page-33-2) bit must be set to 0. The bus master first does an I²C write to the device. In this transaction three bytes are written: the SPI Read command (see [Table 3\)](#page-21-2), the upper byte of the register address, and the lower byte of the register address. The bus master then does an I²C read. During each acknowledge (A) bit the device fetches data from the read address and then increments the read address. The device then transmits the data to the bus master during the next 8 SCL cycles. The bus master terminates the read with a not-acknowledge (NA) followed by a STOP condition (P). See [Figure 9.](#page-25-0) After the I²C write there can be unlimited idle time on the bus before the I²C read, but the device cannot tolerate other I²C bus traffic between the I²C write and the I²C read. Care must be taken to ensure that the $I²C$ read is the first command on the bus after the $I²C$ write to ensure the two-part read transaction happens correctly.

Register Write Transactions. The device registers are accessible when the [EESEL](#page-33-2) bit is 0. The bus master does an I²C write to the device. The first three bytes of this transaction are the SPI Write command (see [Table 3\)](#page-21-2), the upper byte of the register address, and the lower byte of the register address. Subsequent bytes are data bytes to be written. After each data byte is received, the device writes the byte to the write address and then increments the write address. The bus master terminates the write with a STOP condition (P). See [Figure 10.](#page-25-1)

EEPROM Writes (ZL30261 and ZL30263 Only). The EEPROM memory is accessible when the [EESEL](#page-33-2) bit is 1. The bus master first does an I²C write to transmit the SPI Write Enable command (see [Table 3\)](#page-21-2) to the device. The bus master then does an I²C write to transmit data to the device as described in the Register Write Transactions paragraph above. See [Figure 11.](#page-25-2)

EEPROM Read Status (ZL30261 and ZL30263 Only). The bus master first does an I²C write to transmit the SPI Read Status command (see [Table 3\)](#page-21-2) to the device. The bus master then does an I²C read to get the status byte. In this byte, the least significant bit is set to 1 if the transfer is still in progress and 0 if the transfer has completed. See [Figure 12.](#page-25-3) Similar to read transactions described above, the I²C write and the I²C read cannot be separated by other I²C bus traffic.

1²C Features Not Supported by the Device. The I²C specification has several optional features that are not supported by the device. These are: 3.4Mbit/s high-speed mode (Hs-mode), 10-bit device addressing, general call address, software reset, and device ID. The device does not hold SCL low to force the master to wait.

I ²C Slave Address. By default the upper 5 bits of the device's 7-bit slave address are fixed at 11101 and the lower 2 bits can be pin-configured for any of three values as shown in the table in section [5.2.](#page-8-2) For a device that can autoconfigure from EEPROM at power-up, its I²C slave address can be set to any value during auto-configuration at power-up by writing the the [I2CA](#page-42-3) register as part of the configuration script.

Bit Order. The I²C specification requires device address, register address and all data bytes to be transmitted most significant bit first on the SDA signal.

Note: as required by the I²C specification, when power is removed from the device, the SDA and SCL pins are left floating so they don't obstruct the bus lines.

Figure 11 - I ²C EEPROM Write Transaction Functional Timing (ZL30261 and ZL30263 Only)

Figure 12 - I ²C EEPROM Read Status Transaction Functional Timing (ZL30261 and ZL30263 Only)

Note: In [Figure 9](#page-25-0) through [Figure 12,](#page-25-3) a STOP condition (P) immediately followed by a START condition (S) can be replaced by a repeated START condition (Sr) as described in the I²C specification.

5.8 Interrupt Logic

Any of the GPIO pins can be configured as an interrupt-request output by setting the appropriate GPIOxC field in the [GPIOCR](#page-40-0) registers to one of the status output options (01xx) and configuring the appropriate [GPIOxSS](#page-41-0) register to follow the [INTSR.](#page-44-0)INT bit. If system software is written to poll rather than receive interrupt requests, then software can read the [INTSR.](#page-44-0)INT bit first to determine if any interrupt requests are active in the device.

Many of the latched status bits in the device can be the source of an interrupt request if their corresponding interrupt enable bits are set. The device's interrupt logic is shown in [Figure 13.](#page-26-1) See the register map [\(Table 4\)](#page-30-4) and the status register descriptions in section [6.3.2](#page-42-0) for descriptions of the register bits shown in the figure.

Figure 13 - Interrupt Structure

5.9 Reset Logic

The device has three reset controls: the RSTN pin, and the hard reset (HRST) and soft reset (SRST) bits in [MCR1.](#page-35-0) The RSTN pin asynchronously resets the entire device. When the RSTN pin is low all internal registers are reset to their default values. When RSTN returns high the device's auto-configuration boot controller is started. **The RSTN pin must be asserted once after power-up.** Reset should be asserted for at least 1µs. See section [5.9.1](#page-27-1) below for important details about using an external RC reset circuit with the RSTN pin.

Asserting the [MCR1.](#page-35-0)HRST (hard reset) bit is functionally similar to asserting the RSTN pin. The HRST bit resets the entire device except for the microprocessor interface, the HRST bit itself, the [I2CA](#page-42-3) register, and [CFGSR.](#page-43-1)IF[1:0]. While HRST=1 the device accepts register writes so that HRST can be set back to 0, but register reads are not allowed. When HRST is set back to 0, the TEST and AC[2:0] pins are sampled as described in section [5.2,](#page-8-2) but, unlike when RSTN is deasserted, the IF[1:0] pins are not sampled so that the device remains in the same interface mode (SPI or I²C) and maintains the same slave address when in I²C mode. When HRST is set back to 0, the device's auto-configuration boot controller is started after a 1 to $3\mu s$ delay.

The [MCR1.](#page-35-0)SRST (soft reset) bit resets the entire device except for the microprocessor interface, the SRST bit itself, the [MCR1.](#page-35-0)HRST bit, the [I2CA](#page-42-3) register, and the [CFGSR](#page-43-1) register. When the SRST bit is asserted the device's auto-configuration boot controller is **not** started.

Microsemi recommends holding RSTN low while the internal ring oscillator starts up and stabilizes. An incorrect reset condition could result if RSTN is released before the oscillator has started up completely.

Important: System software must wait at least 100µs after RSTN is deasserted and wait for [GLOBISR.](#page-45-0)BCDONE=1 before configuring the device.

5.9.1 Design Considerations for Using an External RC Reset Circuit

When the power supply arrangement for the device has VDDH=VDDL (3.3V or 2.5V) an external RC reset circuit can be used to reset the device during power-up with no additional considerations.

When the power supply arrangement for the device has VDDL=1.8V then the board designer should choose one of two options: (a) a power-on-reset (POR) chip such as a Texas Instruments TPS3839 should be used instead of an external RC reset circuit, or (b) the device's VDDIO pin must be wired to VDDL. In option (a) during the interval between VDDH ramping and VDDL ramping the RSTN pin can briefly behave as an output driving high. Therefore a current-limiting series resistor should be used between the POR chip and the device RSTN pin.

The possible disadvantage of option (b) is that VDDIO, the power supply for all SPI/I2C pins and all GPIO pins, could be too low if neighboring devices operate at power supply voltages higher than VDDL. One exception to this disadvantage would be the I2C interface. Since I2C's logic-high voltage is set by pull-up resistors, those resistors can be externally wired to a voltage higher than VDDIO up to 3.3V. The SCL/SCLK and SDA/MOSI pins are 3.3V tolerant.

5.10 Power-Supply Considerations

Due to the multi-power-supply nature of the device, some I/Os have parasitic diodes between a lower-voltage supply and a higher-voltage supply. When ramping power supplies up or down, care must be taken to avoid forward-biasing these diodes because it could cause latchup. Two methods are available to prevent this. The first method is to place a Schottky diode external to the device between the lower-voltage supply and the higher-voltage supply to force the higher-voltage supply to be within one parasitic diode drop of the lower-voltage supply. The second method is to ramp up the higher-voltage supply first and then ramp up the lower-voltge supply.

Important Note: The voltages on VDDL, VDDIO, and all VDDOx pins must not exceed VDDH. Not complying with this requirement may damage the device.

5.11 Auto-Configuration from EEPROM or ROM

For ZL30260 and ZL30262, the device optionally can configure itself at reset from an internal ROM. The ROM stores eight configurations, known as configurations 0 through 7. As described in section [5.2.1,](#page-9-0) IF[1:0] must be 00, 01 or 10 at reset, and the device configuration to be used is specified by the values of the AC[2:0] pins at reset (0 through 7). Descriptions of the standard-product ROM configurations are available from Microsemi.

For ZL30260 and ZL30262, the device optionally can configure itself at reset from an external EEPROM connected to its SPI interface. The EEPROM can store up to eight configurations, known as configurations 0 through 7. As described in section [5.2.1,](#page-9-0) IF[1:0] must be 11 at reset, and the device configuration to be used is specified by the values of the AC[2:0] pins at reset (0 through 7).

For ZL30261 and ZL30263, the internal EEPROM memory can store up to eight device configurations, known as configurations 0 through 7. As described in section [5.2.2,](#page-9-1) the device configuration to be used is specified by the values of the AC[2:0] pins at reset.

5.11.1 Generating Device Configurations

Device configurations are most easily generated using the evaluation software. This is true for auto-configurations stored in internal or external EEPROM and for configurations that are written to the device by a system processor. See section [5.12](#page-28-3) for guidance if device configurations must be developed without using the evaluation software.

5.11.2 Direct EEPROM Write Mode (ZL30261 and ZL30263 Only)

To simplify writing the device's internal EEPROM during manufacturing, the device has a test mode known as direct EEPROM write mode. The device enters this mode when TEST=1, AC[2:0]=000 and IF[1:0]=11 on the rising edge of RSTN. In this mode the EEPROM memory is mapped into the address map and can be written as needed to store configuration scripts in the device. Device registers are not accessible in this mode. The device exits this mode on the rising edge of RSTN. Note: the device drives the MISO pin continually during this mode. Therefore this mode cannot be used when MOSI and MISO are tied together as described in the **[Design Option: Wiring](#page-22-1) [MOSI and MISO Together](#page-22-1)** paragraph in section [5.7.1.](#page-21-1)

5.11.3 Holding Other Devices in Reset During Auto-Configuration

Using the appropriate [GPIOCR](#page-40-0) and [GPIO0SS](#page-41-0) registers, a GPIO pin can be configured to follow the [GLOBISR.](#page-45-0)BCDONE status bit. This GPIO can then be used as a reset signal to hold other devices (device that use clocks from this device) in reset while the device configures itself. As an example, to configure GPIO0 to follow BCDONE with 0=reset add the following writes at the beginning of the configuration file: write 0x1F to [GPIO0SS](#page-41-0) and write 0x04 to [GPIOCR1.](#page-40-0)

5.12 Configuration Sequence

Device configurations are most easily generated using the evaluation software, which automatically generates configurations that follow Microsemi's suggested sequence. To develop device configurations manually (i.e. from device documentation rather than the evaluation software) see Application Note ZLAN-590 for Microsemi's suggested device configuration sequence.

5.13 Power Supply Decoupling and Layout Recommendations

Application Note ZLAN-592 describes recommended power supply decoupling and layout practices.

5.14 Choosing Among Core Power Supply Options

The device supports the following core supply voltage options:

Choosing the best option depends on several factors including supply voltages available on the board, willingness to use low-dropout (LDO) linear regulators to make local power supplies for the device, board power supply noise and mitigation strategies, target jitter performance, and how many device resources are enabled.

Starting with the VDDH=VDDL=3.3V option, the advantages of this option are (1) the device only requires a single power supply voltage (assuming all output driver VDDOx supplies are also 3.3V), and (2) internal regulation is used for the APLL, maximizing power supply noise rejection. The disadvantage is that power consumption is higher than other options.

The VDDH=3.3V, VDDL=1.8V option does require two core power supply voltages, but internal regulation is used for the APLL, maximizing power supply noise rejection. Also this option does not have either of the two disadvantages of the VDDH=VDDL=3.3V option. *If the application can provide 3.3V and 1.8V supplies to the device, this option is highly recommended as a good balance of lower power consumption and better power supply noise rejection*.

The VDDH=VDDL=2.5 option is for applications that do not have a 3.3V power supply and do not want to provide an LDO to make a 3.3V supply. The advantages of this option are (1) the device only requires a single power supply voltage (assuming all output driver VDDOx supplies are also 2.5V), and (2) lower power consumption than the VDDH=VDDL=3.3V option. The disadvantage is that internal APLL regulators are bypassed and the APLL runs directly from the VDDH supply, which leaves the device more susceptible to power supply noise. This susceptibility can be mitigated using good power supply noise filtering and further mitigated with a dedicated LDO for the device.

The VDDH=2.5V, VDDL=1.8V option provides even lower power consumption than the VDDH=VDDL=2.5V option. The disadvantages are (1) it requires two core power supply voltages, and (2) just like the VDDH=VDDL=2.5V case, internal APLL regulators are bypassed and the APLL runs directly from the VDDH supply, which leaves the device more susceptible to power supply noise. This susceptibility can be mitigated using good power supply noise filtering and further mitigated with a dedicated LDO for the device.

See application note ZLAN-630 for power supply noise rejection performance.

5.15 Path 2 Signal Selection

In addition to the APLL, the device also provides a non-PLL path through the device called Path 2. See the block diagram in [Figure 1.](#page-0-0) Path 2 is essentially a built-in fanout buffer with its own input mux. Each bank of outputs can be connected to the APLL's integer divider, the APLL's fractional divider, or Path 2 using the appropriate field in the [OCMUX](#page-38-1) registers.

The Path 2 input mux can select any of inputs IC1 through IC3, a clock signal on XA, or the crystal driver circuit when a crystal is connected to XA and XB.

The input to Path 2 can be controlled by a register field or a GPIO pin. When [P2CR3.](#page-66-0)EXTSW=0, the P2CR3.MUX register field controls the Path 2 input mux.

When [P2CR3.](#page-66-0)EXTSW=1, a GPIO pin controls the Path 2 input mux. When the GPIO pin is low, the mux selects the input specified by [P2CR3.](#page-66-0)MUX. When the GPIO pin is high, the mux selects the input specified by [P2CR3.](#page-66-0)ALTMUX. [P2CR1.](#page-65-2)EXTSS specifies which GPIO pin controls this behavior.

The [P2SR.](#page-47-1)SELREF real-time status field indicates Path 2's selected reference.

6. Register Descriptions

[Table 4](#page-30-4) shows the register map. In each register, bit 7 is the MSb and bit 0 is the LSb. Register addresses not listed are reserved. Bits marked "—" are reserved and must be written with 0. Writing other values to these registers may put the device in a factory test mode resulting in undefined operation. Bits labeled "0" or "1" must be written with that value for proper operation. Register fields with underlined names are read-only fields; writes to these fields have no effect. All other fields are read-write. Register fields are described in detail in the register descriptions that follow [Table 4.](#page-30-4)

6.1 Register Types

6.1.1 Status Bits

The device has two types of status bits. Real-time status bits are read-only and indicate the state of a signal at the time it is read. Latched status bits are set when a signal changes state (low-to-high, high-to-low, or both, depending on the bit) and cleared when written with a logic 1 value. Writing a 0 has no effect. When set, some latched status bits can cause an interrupt request if enabled to do so by corresponding interrupt enable bits. Status bits marked "—" are reserved and must be ignored.

6.1.2 Configuration Fields

Configuration fields are read-write. During reset, each configuration field reverts to the default value shown in the register definition. Configuration register bits marked "—" are reserved and must be written with 0.

6.1.3 Multiregister Fields

Multiregister fields—such as AFBDIV[41:0] in registers [AFBDIV1](#page-54-0) through [AFBDIV6—](#page-55-0)must be handled carefully to ensure that the bytes of the field remain consistent during writes. A write access to a multiregister field is accomplished by writing all the registers of the field in order from smallest address to largest. Writes to registers other than the last register in the field (i.e. the register with the largest address) are stored in a transfer register. When the last register of the field is written, the entire multiregister field is updated simultaneously from the transfer register. If the last register of the field is not written, the field is not updated.

Read accesses from multiregister fields are the same as normal registers since the multiregister fields are not modified by the device.

An exception for [AFBDIV](#page-54-0) happens when [AFBDL.](#page-53-0)RDCUR=1. In this case reads come directly from the internal logic and don't affect the transfer register. Writes behave the same as above.

The multiregister fields are:

6.1.4 Bank-Switched Registers (ZL30261 and ZL30263 Only)

The [EESEL](#page-33-2) register is a bank-select control field that maps the device registers into the memory map at address 0x1 and above when the [EESEL](#page-33-2) bit is 0 and maps the EEPROM memory into the memory map at address 0x1 and above when the [EESEL](#page-33-2) bit is 1. The [EESEL](#page-33-2) register itself is always in the memory map at address 0x0.

6.2 Register Map

Table 4 - Register Map

ZL30260-ZL30263 Data Sheet

6.3 Register Definitions

6.3.1 Global Configuration Registers

Bit 7: EEPROM Memory Select (EESEL). This bit is a bank-select that specfies whether device register space or EEPROM memory is mapped into addresses 0x1 and above. This applies only to the ZL30261 and ZL30263. The ZL30260 and ZL30262 do not have internal EEPROM memory. Note that ROMSEL has priority over EESEL. See sections [5.7](#page-21-0) and [6.1.4.](#page-30-3)

 $0 =$ Device registers

1= EEPROM memory

Register Name: MCR1 **Register Address:** 01h

Register Description: Master Configuration Register 1

Bit 7: Soft Reset (SRST). This bit resets the entire device except for the microprocessor interface, the SRST bit itself, the [MCR1.](#page-35-0)HRST bit, the [I2CA](#page-42-3) register, and [CFGSR](#page-43-1) bits 5:0. When SRST is active, the register fields with pin-programmed defaults do not latch their values from the corresponding input pins. When the SRST bit is asserted the device's auto-configuration boot controller is **not** started. See section [5.9.](#page-27-0)

0 = Normal operation

 $1 =$ Reset

Bit 6: Hard Reset (HRST). Asserting this bit is functionally equivalent to asserting the RSTN pin. The HRST bit resets the entire device except for the microprocessor interface and the HRST bit itself. Register fields with pinprogrammed defaults latch their values from the corresponding input pins, and the device's auto-configuration boot controller is started. See section [5.9.](#page-27-0)

 $0 =$ Normal operation

 $1 =$ Reset

Bit 5: Output Clock Stop (STOP). Asserting this bit stops all output clocks that are configured with [OCxSTOP.](#page-72-1)SRC=0001. Note that this signal is ORed with the per-output stop control bit in the [STOPCR](#page-39-0) registers to make each output's internal stop control signal. See section [5.6.7.](#page-20-4)

Bit 3: Ring Oscillator Disable (ROSCD). This bit disables the ring oscillator. It can be set to 1 when autoconfiguration is complete. See section [5.3.4.](#page-12-0)

 $0 =$ Enable

1 = Disable (power-down)

Bit 1: Open Drain MISO Enable (ODMISO). This bit configures the MISO pin to be open-drain. When this bit is set, the MISO pin only drives low and must have an external pullup resistor.

0 = Disable (MISO drives 0 and 1, high-impedance when not driven)

1 = Enable (MISO drives 0 only, high-impedance all other times)

Register Name: MCR2 **Register Address:** 02h

Register Description: Master Configuration Register 2

Bit 7: XA Monitor Clock (XAMCK). Leave this bit set to 0.

Bit 6: IC3 Monitor Clock (IC3MCK). Leave this bit set to 0.

Bit 5: IC2 Monitor Clock (IC2MCK). Leave this bit set to 0.

Bit 4: IC1 Monitor Clock (IC1MCK). Leave this bit set to 0.

Bit 2: Clock Doubler Enable (DBL). This bit enables the clock doubler for either the output of the crystal driver circuitry or the signal on the XA pin. During power-up, system software must wait at least 5ms for the crystal driver circuit to stabilize before enabling the clock doubler. See section [5.3.3.](#page-11-0)

0 = Disable (power down)

 $1 =$ Enable

Bits 1 to 0: XA/XB Pin Mode (XAB[1:0]). This field specifies the behavior of the XA and XB pins. See section [5.3.](#page-10-0)

00 = Crystal driver and input disabled / powered down

01 = Crystal driver and input enabled on XA/XB

10 = XA enabled as single-ended input for external oscillator signal; XB must be left floating

 $11 = \{$ unused value $\}$

ZL30260-ZL30263 Data Sheet

Bit 0: APLL Enable (APLLEN). This bit enables or disables the APLL. See section [5.5.4.](#page-13-0)

 $0 = Disabled$

 $1 =$ Enabled

Bit 2: Input Clock 3 Enable (IC3EN). This bit enables and disables the input clock 3 differential receiver and input dividers. See section [5.4.](#page-12-0)

 $0 = Disabled$

 $1 =$ Enabled

Bit 1: Input Clock 2 Enable (IC2EN). This bit enables and disables the input clock 2 differential receiver and input dividers. See section [5.4.](#page-12-0)

 $0 = Disabled$

 $1 =$ Enabled

Bit 0: Input Clock 1 Enable (IC1EN). This bit enables and disables the input clock 1 differential receiver and input dividers. See section [5.4.](#page-12-0)

- $0 = Disabled$
- $1 =$ Enabled

Register Name: OCEN1 **Register Address:** 05h

Register Description: Output Clock Enable Register 1

Bits 7 to 0: Output Clock x Enable (OCxEN). Each of these bits enables and disables the corresponding output dividers, phase adjustment/alignment circuitry and start/stop circuitry. See section [5.6.1.](#page-18-0)

 $0 = Disabled$

 $1 =$ Enabled

Note: On Rev A devices at least one OCxEN bit must be set for each of the six output banks for proper operation. These bits should be set at or near the beginning of the configuration sequence.

Register Name: OCEN2 **Register Address:** 06h

Register Description: Output Clock Enable Register 2

See the [OCEN1](#page-38-0) register description above.

Bits 5 to 4: Output Clock Mux C (OCMUXC[1:0]). Controls the high speed output mux for output group C (OC4 and OC5).

00 = APLL Integer divider

 01 = APLL Fractional divider or bypass path (specified by $ACR1.BYPASS$)

 $10 =$ {unused value}

11 = Path 2 (see block diagram in [Figure 1\)](#page-0-0)

Bits 3 to 2: Output Clock Mux B (OCMUXB[1:0]). Controls the high speed output mux for output group B (OC3).

00 = APLL Integer divider

 01 = APLL Fractional divider or bypass path (specified by $ACR1.BYPASS$)

 $10 =$ {unused value}

11 = Path 2 (see block diagram in [Figure 1\)](#page-0-0)

Bits 1 to 0: Output Clock Mux A (OCMUXA[1:0]). Controls the high speed output mux for output group A (OC1 and OC2).

00 = APLL Integer divider

 01 = APLL Fractional divider or bypass path (specified by $ACR1.BYPASS$)

 $10 = \{$ unused value $\}$

11 = Path 2 (see block diagram in [Figure 1\)](#page-0-0)

Bits 5 to 4: Output Clock Mux F (OCMUXF[1:0]). Controls the high speed output mux for output group F (OC9 and OC10).

00 = APLL Integer divider

 01 = APLL Fractional divider or bypass path (specified by $ACR1.BYPASS$)

 $10 = \{$ unused value $\}$

11 = Path 2 (see block diagram in [Figure 1\)](#page-0-0)

Bits 3 to 2: Output Clock Mux E (OCMUXE[1:0]). Controls the high speed output mux for output group E (OC8).

00 = APLL Integer divider

 01 = APLL Fractional divider or bypass path (specified by $ACR1.BYPASS$)

 $10 = \{$ unused value $\}$

11 = Path 2 (see block diagram in [Figure 1\)](#page-0-0)

Bits 1 to 0: Output Clock Mux D (OCMUXD[1:0]). Controls the high speed output mux for output group D (OC6 and OC7).

00 = APLL Integer divider

 01 = APLL Fractional divider or bypass path (specified by $ACR1.BYPASS$)

 $10 =$ {unused value}

11 = Path 2 (see block diagram in [Figure 1\)](#page-0-0)

Bit 7: OC8 Stop Control (OC8STP). When SRC=0001 in the [OC8STOP](#page-72-0) register, setting this bit to 1 causes OC8 to stop. Note that this signal is ORed with [MCR1.](#page-35-0)STOP to make OC8's internal stop control signal. See section [5.6.7.](#page-20-0)

Bits 6 to 0: These bits are similar to OC8STP above but for OC7 through OC1.

Bits 1 to 0: These bits are similar to STOPCR1.OC8STP but for OC10 and OC9.

Bits 7 to 4: GPIO1 Configuration (GPIO1C[3:0]). This field configures the GPIO1 pin as a general-purpose input, a general-purpose output driving low or high, or a status output. The current state of the pin can be read from [GPIOSR.](#page-43-0)GPIO1. When GPIO1 is a status output, the [GPIO1SS](#page-41-0) register specifies which status bit is output.

0000 = General-purpose input

0001 = General-purpose input - inverted polarity

0010 = General-purpose output driving low

0011 = General-purpose output driving high

0100 = Status output – non-inverted polarity

0101 = Status output - inverted polarity of the status bit it follows

 $0110 =$ Status output – 0 drives low, 1 high impedance

 $0111 =$ Status output -0 high impedance, 1 drives low

1000 to $1111 = \{$ unused values $\}$

Bits 3 to 0: GPIO0 Configuration (GPIO0C[3:0]). This field configures the GPIO0 pin as a general-purpose input, a general-purpose output driving low or high, or a status output. The current state of the pin can be read from [GPIOSR.](#page-43-0)GPIO0. When GPIO0 is a status output, the [GPIO0SS](#page-41-1) register specifies which status bit is output.

0000 = General-purpose input

0001 = General-purpose input - inverted polarity

0010 = General-purpose output driving low

0011 = General-purpose output driving high

0100 = Status output – non-inverted polarity

0101 = Status output - inverted polarity of the status bit it follows

 $0110 =$ Status output – 0 drives low, 1 high impedance

 $0111 =$ Status output -0 high impedance, 1 drives low

1000 to 1111 = ${unused values}$

Note that the bits of the following registers cannot be internally connected to a GPIO configured as a status output: [GPIOSR,](#page-43-0) [APLLIE.](#page-48-0)

These fields are identical to those in [GPIOCR1](#page-40-0) except they control GPIO2 and GPIO3.

Register Name: GPIO0SS **Register Address:** 0Dh

Register Description: GPIO0 Status Select Register

Bits 7 to 3: Status Register (REG[4:0]). When [GPIOCR1.](#page-40-0)GPIO0C=01xx, this field specifies the register of the status bit that GPIO0 will follow while the BIT field below specifies the status bit within the register. Setting the combination of this field and the BIT field below to point to a bit that isn't implemented as a real-time or latched status register bit results in GPIO0 being driven low. The address of the status bit that GPIO0 follows is 0[x40](#page-43-1) + REG[4:0]

Bits 2 to 0: Status Bit (BIT[2:0]). When [GPIOCR1.](#page-40-0)GPIO0C=01xx, the REG field above specifies the register of the status bit that GPIO0 will follow while this field specifies the status bit within the register. Setting the combination of the REG field and this field to point to a bit that isn't implemented as a real-time or latched status register bit results in GPIO1 being driven low. 000=bit 0 of the register. 111=bit 7 of the register.

Note: The device does not allow the GPIO status register bits in [GPIOSR](#page-43-0) to be followed by a GPIO.

These fields are identical to those in [GPIO0SS](#page-41-1) except they control GPIO1.

These fields are identical to those in [GPIO0SS](#page-41-1) except they control GPIO2.

These fields are identical to those in [GPIO0SS](#page-41-1) except they control GPIO3.

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Bits 6 to 0: I2C Address (I2CA[6:0]). This field specifies the device's address on the I²C bus. At the assertion of the RSTN pin, bits 6:2 are set to the default values shown above, and bits 1:0 are set to the states of the IF1 and IF0 pins. The [MCR1.](#page-35-0)HRST and MCR1.SRST bits have no effect on these bits. After reset these bits can be written by system software to change the device's I²C address as needed. Note: the value I2CA=0 is invalid.

6.3.2 Status Registers

Bits 7 to 0: Device ID Upper (IDU[7:0]). This field is the upper eight bits of the device ID.

Bits 7 to 4: Device ID Lower (IDL[3:0]). This field is the lower four bits of the device ID.

Default See below see below contract factory

 $ZL30260 = 0x1D0$ $ZL30261 = 0x1F0$ $ZL30262 = 0x1D1$ $ZL30263 = 0x1F1$

Bits 3 to 0: Device Revision (REV[3:0]). These bits are the device hardware revision starting at 0.

Register Name: CFGSR **Register Address:** 40h

`

Register Description: Configuration Status Register

Bit 7: Configured (CFGD). This read-only bit is cleared by assertion of RSTN, [MCR1.](#page-35-0)HRST or MCR1.SRST and set when any register is written (by auto-configuration or through the processor interface). CFGD=1 indicates that the device register set is no longer in factory-default state, and, therefore, the device must be reset before a GUIgenerated configuration script is executed.

Bits 5 to 4: Interface Mode (IF[1:0]). These read-only bits are the latched state of the IF1/MISO and IF0/CSN pins when the RSTN pin transitions high. See section [5.2.](#page-8-0)

Bit 3: Test Mode (TEST). This read-only bit is the latched state of the TEST/GPIO3 pin when the RSTN pin transitions high or the [MCR1.](#page-35-0)HRST bit is deasserted. For proper operation it should be 0. See section [5.2.](#page-8-0)

Bits 2 to 0: Auto-Configuration (AC[2:0]). These bits are the latched state of the AC2/GPIO2, AC1/GPIO1 and AC0/GPIO0 pins when the RSTN pin transitions high or the [MCR1.](#page-35-0)HRST bit is deasserted. See section [5.2.](#page-8-0)

Bit 7: GPIO3 Change Latched Status (GPIO3L). This latched status bit is set to 1 when the GPIO3 status bit changes state, low-to-high or high-to-low. GPIO3L is cleared when written with a 1. When GPIO3L is set it can cause an interrupt request if the GPIO3IE interrupt enable bit is set.

Bit 6: GPIO2 Change Latched Status (GPIO2L). This latched status bit is set to 1 when the GPIO2 status bit changes state, low-to-high or high-to-low. GPIO2L is cleared when written with a 1. When GPIO2L is set it can cause an interrupt request if the GPIO2IE interrupt enable bit is set.

Bit 5: GPIO1 Change Latched Status (GPIO1L). This latched status bit is set to 1 when the GPIO1 status bit changes state, low-to-high or high-to-low. GPIO1L is cleared when written with a 1. When GPIO1L is set it can cause an interrupt request if the GPIO1IE interrupt enable bit is set.

Bit 4: GPIO0 Change Latched Status (GPIO0L). This latched status bit is set to 1 when the GPIO0 status bit changes state, low-to-high or high-to-low. GPIO0L is cleared when written with a 1. When GPIO0L is set it can cause an interrupt request if the GPIO0IE interrupt enable bit is set.

Bit 3: GPIO3 State (GPIO3). This real-time status bit indicates the current state of the GPIO3 pin, not influenced by any inversion that may be specified by [GPIOCR2.](#page-40-1)GPIO3C.

 $0 =$ low

 $1 = high$

Bit 2: GPIO2 State (GPIO2). This real-time status bit indicates the current state of the GPIO2 pin, not influenced by inversion that may be specified by [GPIOCR2.G](#page-40-1)PIO2C.

 $0 =$ low

 $1 = high$

Bit 1: GPIO1 State (GPIO1). This real-time status bit indicates the current state of the GPIO1 pin, not influenced by inversion that may be specified by [GPIOCR1.G](#page-40-0)PIO1C.

 $0 =$ low

 $1 = high$

Bit 0: GPIO0 State (GPIO0). This real-time status bit indicates the current state of the GPIO0 pin, not influenced by inversion that may be specified by [GPIOCR1.G](#page-40-0)PIO0C.

 $0 =$ low

 $1 =$ high

Bit 5: Output Clock Interrupt Status (OC). This read-only bit is set if any of the output clock interrupt status bits are set in the [OCISR1](#page-46-0) register. See section [5.8.](#page-26-0)

Bit 4: Input Clock Interrupt Status (IC). This read-only bit is set if any of the input clock interrupt status bits are set in the **ICISR** register. See section [5.8.](#page-26-0)

Bit 2: APLL Interrupt Status (APLL). This read-only bit is set if any of the APLL interrupt status bits are set in the [APLLISR](#page-46-2) register. See section [5.8.](#page-26-0)

Bit 1: Interrupt Enable Bit (INTIE). This is the global interrupt enable bit. When this bit is 0 all interrupt sources are prevented from setting the INT global interrupt status bit (below). See section [5.8.](#page-26-0)

 $0 =$ Interrupts are disabled at the global level

 $1 =$ Interrupts are enabled at the global level

Bit 0: Interrupt Status (INT). This read-only bit is set when any of the IC, OC or APLL bits in this [INTSR](#page-44-0) register are set and the INTIE bit is set. It is also set by GPIO latched status bits that have their corresponding interrupt enable bits set. This bit can cause an interrupt request when set by configuring one of the GPIO pins to follow it. See section [5.8.](#page-26-0)

 $0 = No$ interrupt

 $1 = An$ unmasked interrupt source is active

Register Name: GLOBISR **Register Address:** 43h

Register Description: Global Functions Interrupt Status Register

Bit 7: Boot Controller Done (BCDONE). This bit indicates the status of the on-chip boot controller, which performs auto-configuration from ROM or EEPROM. It is cleared when the device is reset and set after the boot controller finishes auto-configuration of the device. See section [5.11.](#page-27-0)

Note that BCDONE cannot be polled while the device is auto-configuring because the internal register bus is in use. The BCDONE bit was designed to be followed by a GPIO pin configured as a status output. To cause GPIO0, for example, to follow BCDONE, include the following settings at the beginning of the auto-configuration script: [GPIOCR1=](#page-40-0)0x04 (configures GPIO0 as a non-inverted status output) and [GPIO0SS=](#page-41-1)00011 111b (causes GPIO0 to follow the bit at register 0x43, bit 7, which is BCDONE).

Alternately, there is a way to poll the device to determine whether auto-configuration is complete. This involves choosing a writeable bit that (a) has a harmless effect, such as [GLOBISR.](#page-45-0)GPIO3IE, and (b) is not set during autoconfiguration. System software can then poll the device by writing the register to set the bit then reading the register to see if the bit is set. The bit cannot be set by system software while the device is auto-configuring. Therefore when it is found to be set auto-configuration must be complete.

Bit 3: GPIO3 Change Interrupt Enable (GPIO3IE). This bit enables the [GPIOSR.](#page-43-0)GPIO3L latched status bit to send an interrupt request into the device's interrupt logic.

- $0 =$ Interrupt is disabled
- $1 =$ Interrupt is enabled

Bit 2: GPIO2 Change Interrupt Enable (GPIO2IE). This bit enables the [GPIOSR.](#page-43-0)GPIO2L latched status bit to send an interrupt request into the device's interrupt logic.

- $0 =$ Interrupt is disabled
- $1 =$ Interrupt is enabled

Bit 1: GPIO1 Change Interrupt Enable (GPIO1IE). This bit enables the [GPIOSR.](#page-43-0)GPIO1L latched status bit to send an interrupt request into the device's interrupt logic.

- $0 =$ Interrupt is disabled
- $1 =$ Interrupt is enabled

Bit 0: GPIO0 Change Interrupt Enable (GPIO0IE). This bit enables the [GPIOSR.](#page-43-0)GPIO0L latched status bit to send an interrupt request into the device's interrupt logic.

- $0 =$ Interrupt is disabled
- $1 =$ Interrupt is enabled

Register Name: ICISR **Register Address:** 44h

Register Description: Input Clock Interrupt Status Register

Bit 3: XA Input Interrupt Status (XA). This bit indicates the current status of the interrupt sources for XA. This bit is set when latched status [XASR.](#page-49-0)XAL is set and the associated interrupt enable bit is also set. See section [5.8.](#page-26-0)

Bit 2 to 0: Input Clock x Interrupt Status (IC[3:1]). Each bit indicates the current status of the interrupt sources for the corresponding input. It is set when latched status [ICxSR.](#page-49-1)ICVL is set and the associated interrupt enable bit is also set. See section [5.8.](#page-26-0)

Register Name: OCISR1 **Register Address:** 45h

Register Description: Output Clock Interrupt Status Register 1

Bits 7 to 0: Output Clock x Interrupt Status (OC[8:1]). Each bit indicates the current status of the interrupt sources for the corresponding output. It is set when any latched status bit in the [OCxSR](#page-50-0) register is set and the associated interrupt enable bit is also set. See section [5.8.](#page-26-0)

Register Name: OCISR2
 Register Description: Output C **Output Clock Interrupt Status Register 2 Register Address:** 46h

See the [OCISR1](#page-46-0) register description above.

Bit 0: APLL Interrupt Status (APLL). This bit indicates the current status of the interrupt sources for the APLL. It is set when any latched status bit in the [APLLSR](#page-47-0) register is set and the associated interrupt enable bit is also set. See section [5.8.](#page-26-0)

Bit 7: APLL Input Frequency Low Latched Status (AIFLL). This latched status bit is set to 1 when the AIFL status bit is set. AIFLL is cleared when written with a 1. When AIFLL is set it can cause an interrupt request if the AIFLIE interrupt enable bit is set.

Bit 6: APLL Input Frequency Low Status (AIFL). This real-time status bit indicates that the input frequency to the APLL is lower that expected.

- $0 =$ Input frequency ok
- $1 =$ Input frequency low

Bit 5: APLL Input Frequency High Latched Status (AIFHL). This latched status bit is set to 1 when the AIFH status bit is set. AIFHL is cleared when written with a 1. When AIFHL is set it can cause an interrupt request if the AIFHIE interrupt enable bit is set.

Bit 4: APLL Input Frequency High Status (AIFH). This real-time status bit indicates that the input frequency to the APLL is higher that expected.

- $0 =$ Input frequency ok
- $1 =$ Input frequency high

Bit 3: APLL Lock Latched Status (ALKL). This latched status bit is set to 1 when the ALK status bit changes state (set or cleared). ALKL is cleared when written with a 1. When ALKL is set it can cause an interrupt request if the ALKIE interrupt enable bit is set.

Bit 2: APLL Lock Status (ALK). This real-time status bit indicates the lock status of the APLL. See section [5.5.](#page-12-1)

- $0 = Not locked$
- $1 =$ Locked

Bit 0: Selected Reference (SELREF). This real-time status field indicates the APLL's selected reference. See section [5.5.3.](#page-12-2)

 $0 =$ The input specified by [ACR3.](#page-52-0)APLLMUX

 $1 =$ The input specified by $ACR3$. ALTMUX

Bit 0: Selected Reference (SELREF). This real-time status field indicates Path 2's selected reference. See section [5.15.](#page-29-0)

 $0 =$ The input specified by [P2CR3.](#page-66-0)MUX

1 = The input specified by [P2CR3.](#page-66-0)ALTMUX

Register Name: APLLIE **Register Address:** 4Ah

Register Description: APLL Interrupt Enable Register

Bit 7: APLL Input Frequency Low Interrupt Enable (AIFLIE). This bit enables the AIFLL latched status bit to send an interrupt request into the device's interrupt logic.

 $0 =$ Interrupt is disabled

 $1 =$ Interrupt is enabled

Bit 5: APLL Input Frequency High Interrupt Enable (AIFHIE). This bit enables the AIFHL latched status bit to send an interrupt request into the device's interrupt logic.

 $0 =$ Interrupt is disabled

 $1 =$ Interrupt is enabled

Bit 3: APLL Lock Interrupt Enable (ALKIE). This bit enables the ALKL latched status bit to send an interrupt request into the device's interrupt logic.

 $0 =$ Interrupt is disabled

 $1 =$ Interrupt is enabled

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Register Name: XASR Register Address: 4Ch

Register Description: XA Input Status Register

The fields in the register are the same as the fields in the [ICxSR](#page-49-1) registers except they apply to the XA input.

Register Name: ICxSR
 Register Description: Input C

Input Clock Status Register Register Address: IC1: 4Dh, IC2: 4Eh, IC3: 4Fh

Bit 3: Input Clock Valid Interrupt Enable (ICVIE). This bit enables the [ICxSR.](#page-49-1)ICVL latched status bit to send an interrupt request into device's interrupt logic.

 $0 =$ Interrupt is disabled

1 = Interrupt is enabled

Bit 2: Input Clock Valid Latched (ICVL). This latched status bit is set to 1 when the [ICxSR.](#page-49-1)ICV status bit changes state (set or cleared). This bit is cleared when written with a 1 and not set again until the [ICxSR.](#page-49-1)ICV bit changes state again. This bit can be the source of an interrupt request. See section [5.5.2.](#page-12-3)

 $0 = ICx$ SR.ICV bit has not changed state since last cleared

 $1 = ICxSR.$ ICV bit has changed state since last cleared

Bit 1: Input Clock Valid (ICV). This real-time status bit is high when the input clock monitor indicates the input is valid. See section [5.5.2.](#page-12-3)

 $0 =$ The input clock is not valid

 $1 =$ The input clock is valid

Register Name: OCxSR

Register Description: Output Clock x Status Register **Register Address:** OC1: 50h, OC2: 51h, OC3: 52h, OC4: 53h, OC5: 54h OC6: 55h, OC7: 56h, OC8: 57h, OC9: 58h, OC10: 59h

Bit 7: (LSCLKIE). This bit enables the LSCLKL latched status bit to send an interrupt request into device's interrupt logic.

 $0 =$ Interrupt is disabled

 $1 =$ Interrupt is enabled

Bit 6: (LSCLKL). This latched status bit is set when the low-speed divider output clock transitions low-to-high. Writing a 1 to this bit clears it.

 $0 =$ Low speed output clock has not transitioned low to high

1 = Low speed output clock has transitioned low to high

Bit 5: (LSCLK). This real-time status bit follows the level of the low-speed divider output clock when the [OCxCR3.](#page-70-0)SRLSEN bit is set.

 $0 =$ LSCLK is high

 $1 =$ LSCLK is low

Bit 4: (STARTIE). This bit enables the STARTL latched status bit to send an interrupt request into device's interrupt logic.

 $0 =$ Interrupt is disabled

 $1 =$ Interrupt is enabled

Bit 3: (STARTL). This latched status bit is set when the output clock signal has been started after being stopped. Writing a 1 to this bit clears it. See section [5.6.6.](#page-20-1)

0 = Output clock signal has not resumed from being stopped

1 = Output clock signal has resumed from being stopped

Bit 2: (STOPIE). This bit enables the STOPL latched status bit to send an interrupt request into device's interrupt logic.

 $0 =$ Interrupt is disabled

 $1 =$ Interrupt is enabled

Bit 1: (STOPL). This latched status bit is set when the output clock signal has been stopped. Writing a 1 to this bit clears it. See section [5.6.6.](#page-20-1)

 $0 =$ Output clock signal has not stopped

 $1 =$ Output clock signal has stopped

Bit 0: (STOPD). This real-time status bit is high when the output clock signal is stopped and low when the output clock is not stopped. See section [5.6.6.](#page-20-1)

 $0 =$ Output clock signal is not stopped

 $1 =$ Output clock signal is stopped

6.3.3 APLL Configuration Registers

Bit 7: Enable Frequency Increment/Decrement (ENFID). This bit enables frequency increment/decrement behavior as described in section [5.5.7.](#page-16-0)

Bit 6: Align Output Dividers (DALIGN). A 0-to-1 transition on this bit causes a simultaneous reset of the medium-speed dividers and the low-speed dividers for all output clocks where [OCxCR1.](#page-67-0)PHEN=1. After this reset all PHEN=1 output clocks with frequencies that are exactly integer multiples of one another will be rising-edge aligned as specified by their [OCxPH](#page-72-1) registers. This bit should be set then cleared once during system startup. Setting this bit during normal system operation can cause phase jumps in the output clock signals.

Bits 5 to 4: External Switch Source Select (EXTSS[1:0]). This field selects the GPIO source for the external switch control signal. It is only valid when [ACR3.](#page-52-0)EXTSW=1. See section [5.5.1.](#page-12-4)

 $00 = GPIOO$ 01 = GPIO1 $10 = GPIO2$ $11 = GPIO3$

Bit 3: Use Fractional Divider (USEFDIV). This bit controls which resource the spread spectrum logic controls. See section [5.5.8.2.](#page-17-0)

- 0 = APLL feedback divider
- $1 =$ fractional output divider

Bit 2: Enable Fractional Divider (ENFDIV). This bit is an enable/disable control for the APLL's fractional divider. When the fractional divider is disabled, device power consumption is reduced as shown in [Table 6.](#page-76-0) The fractional divider is enabled when [PLLEN.](#page-37-0)APLLEN=1, ENFDIV=1 and [ACR1.](#page-51-0)BYPASS=0.

- $0 = Disable$
- $1 =$ Enable

Bit 1: Bypass APLL and Fractional Divider (BYPASS). This bit controls selection between the APLL's fractional divider and the APLL's bypass path as shown in [Figure 1.](#page-0-0) The mux that provides the bypass signal to this mux is controlled by APLLMUX and related fields in [ACR3.](#page-52-0)

 $0 = No$ bypass $1 = Bypass$

Bit 0: APLL Input Doubler Enable (INDBL). This bit enables a simple clock doubler at the input to the APLL. This feature allows signals from IC1, IC2 or IC3 to be doubled which often can result in lower output jitter. See section [5.3.3.](#page-11-0)

Bits 3 to 0: APLL Integer Divider (INTDIV[3:0]). This field controls the APLL's integer divider (see [Figure 5\)](#page-13-1). See section [5.5.4.](#page-13-0)

Bit 7: APLL Input Monitor Switching Mode (INMON). This bit enables the APLL input monitor loss of signal reference switching mode. In this mode, if the input specified by the APLLMUX field satisfies the loss-of-signal condition, the APLL input mux will switch to the input specified by the ALTMUX field. See section [5.5.3.](#page-12-2)

Bit 6: APLL External Switching Mode (EXTSW). This bit enables APLL external reference switching mode. In this mode, if the selected GPIO signal is low the APLL input mux is controlled by [ACR3.](#page-52-0)APLLMUX. If the selected GPIO signal is high the APLL input mux is controlled by [ACR3.](#page-52-0)ALTMUX. [ACR1.](#page-51-0)EXTSS specifies which GPIO pin controls this behavior. See section [5.5.3.](#page-12-2)

Bits 5 to 3: APLL Alternate Mux Control (ALTMUX[2:0]). This field specifies the alternate APLL clock source for external switching (when EXTSW=1) and for automatic switching based on monitor status (when EXTSW=0 an INMON=1). See section [5.5.3.](#page-12-2)

 $000 = IC1$ input (default) $001 = IC2$ input $010 = IC3$ input $011 = XA$ not doubled $100 = XA$ doubled (must have [MCR2.](#page-36-0)DBL = 1) $101-111 = {reserveed values}$

Bits 2 to 0: APLL Mux Control (APLLMUX[2:0]). By default this field controls the APLL input mux. It also specifies the primary APLL clock source for external switching (when EXTSW=1) and for automatic switching based on monitor status (when EXTSW=0 and INMON=1). See section [5.5.3.](#page-12-2)

 $000 = IC1$ input $001 = IC2$ input $010 = IC3$ input $011 = XA$ not doubled (default) $100 = XA$ doubled (must have [MCR2.](#page-36-0)DBL =1) $101-111 = {reserveed values}$

Register Name: ACR4 **Register Address:** 103h

Register Description: APLL Configuration Register 4

Bit 7: Decrement Phase (DECPH). When PDSS=000, this bit is the APLL phase decrement control signal. See section [5.5.9.](#page-18-1)

Bits 6 to 4: Phase Decrement Source Select (PDSS[2:0]). This field specifies the APLL phase decrement control signal. Every low-to-high transition and every high-to-low transition of the signal decrements the APLL's output phase. See section [5.5.9.](#page-18-1)

 $000 = DECPH$ bit $001 = GPIOO$ $010 = GPIO1$ $011 = GPIO2$ $100 = GPIO3$ 101 to 111 = ${unused values}$

Bit 3: Increment Phase (INCPH). When PISS=000, this bit is the APLL phase increment control signal. See section [5.5.9.](#page-18-1)

Bits 2 to 0: Phase Increment Source Select (PISS[2:0]). This field specifies the APLL phase increment control signal. Every low-to-high transition and every high-to-low transition of the signal increments the APLL's output

phase. See section [5.5.9.](#page-18-1) $000 = INCPH$ bit $001 = GPIOO$ $010 = GPIO1$ $011 = GPIO2$ $100 = GPIO3$ 101 to $111 = \{$ unused values $\}$

Bit 7: External Feedback Enable (EXTFB).

0 = Internal feedback through the APLL's fractional feedback divider

1 = External feedback (typically for output vs. input phase alignment)

Bits 6 to 5: External Feedback Select (FBSEL[1:0]). When EXTFB=1, this field specifies the external feedback path.

00 = from any OCx output through external path to IC1 input to APLL's feedback input

01 = from any OCx output through external path to IC2 input to APLL's feedback input

10 = from any OCx output through external path to IC3 input to APLL's feedback input

11 = from OC1 output through internal (on-die) path to APLL's feedback input

Bit 4: Read Current AFBDIV Value (RDCUR). See section [5.5.7.](#page-16-0) The system must not cause any frequency increments or decrements during the read of the current APLL feedback divider value; otherwise the bytes of the value read may not be coherent.

- $0 =$ Read the original APLL feedback divider value written to the [AFBDIV](#page-54-0) registers by system software
- 1 = Read the current APLL feedback divider value after increments and decrements

Bits 2 to 0: APLL Feedback Divider Write Length (AFBDL[2:0]). This field indicates the last register to write of the [AFBDIV](#page-54-0) multiregister field where "last register" is as described in section [6.1.3.](#page-30-0) The number of the last register to write is [AFBDL+](#page-53-0)1. The default of 5 specifies [AFBDIV6](#page-55-0) as described in section [6.1.3.](#page-30-0) Changing this field from its default value can be useful in NCO mode to reduce SPI or I2C bus usage when NCO changes only affect the least significant bytes of [AFBDIV.](#page-54-0)

Bits 7 to 0: APLL Feedback Divider Register (AFBDIV[7:0]). The full 42-bit AFBDIV[41:0] field spans the AFBDIV1 through AFBDIV6 registers. AFBDIV is an unsigned number with 9 integer bits (AFBDIV[41:33]) and up to 33 fractional bits. AFBDIV specifies the fixed-point term of the APLL's fractional feedback divide value. The value AFBDIV=0 is undefined. Unused least significant bits must be written with 0. See section [5.5.4.](#page-13-0)

Bits 7 to 0: APLL Feedback Divider Register (AFBDIV[15:8]). See the [AFBDIV1](#page-54-0) register description.

Bits 7 to 0: APLL Feedback Divider Register (AFBDIV[23:16]). See the [AFBDIV1](#page-54-0) register description.

Register Name: AFBDEN1 **Register Address:** 10Ch

Register Description: APLL Feedback Divider Denominator Register 1

Bits 7 to 0: APLL Feedback Divider Denominator Register (AFBDEN[7:0]). The full 32-bit AFBDEN[31:0] field spans [AFBDEN1](#page-56-0) through [AFBDEN4](#page-56-1) registers. AFBDEN is an unsigned integer that specifies the denominator of the APLL's fractional feedback divide value. The value AFBDEN=0 is undefined. When [AFBBP=](#page-58-0)0, [AFBDEN](#page-56-0) must be set to 1. See section [5.5.4.](#page-13-0)

Register Name: AFBDEN2 **Register Description:** APLL Feedback Divider Denominator Register 2 **10Dh**

Bits 7 to 0: APLL Feedback Divider Denominator Register (AFBDEN[15:8]). See the [AFBDEN1](#page-56-0) register description.

Bits 7 to 0: APLL Feedback Divider Denominator Register (AFBDEN[23:16]). See the [AFBDEN1](#page-56-0) register description.

Bits 7 to 0: APLL Feedback Divider Denominator Register (AFBDEN[31:24]). See the [AFBDEN1](#page-56-0) register description.

Register Name: AFBREM1 **Register Address:** 110h

Register Description: APLL Feedback Divider Remainder Register 1

Bits 7 to 0: APLL Feedback Divider Remainder Register (AFBREM[7:0]). The full 32-bit AFBDEN[31:0] field spans [AFBREM1](#page-57-0) through [AFBREM4](#page-57-1) registers. AFBREM is an unsigned integer that specifies the remainder of the APLL's fractional feedback divider value. See section [5.5.4.](#page-13-0)

Register Name: AFBREM2 **Register Address:** 111h

Register Description: APLL Feedback Divider Remainder Register 2

Bits 7 to 0: APLL Feedback Divider Remainder Register (AFBREM[15:8]). See the [AFBREM1](#page-57-0) register description.

Bits 7 to 0: APLL Feedback Divider Remainder Register (AFBREM[23:16]). See the [AFBREM1](#page-57-0) register description.

Register Name: AFBREM4 **Register Description:** APLL Feedback Divider Remainder Register 4 **Register Address:** 113h

Bits 7 to 0: APLL Feedback Divider Remainder Register (AFBREM[31:24]). See the [AFBREM1](#page-57-0) register description.

Register Name: AFBBP **Register Address:** 114h

Register Description: APLL Feedback Divider Truncate Bit Position

Bits 7 to 0: APLL Feedback Divider Truncate Bit Position (AFBBP[7:0]). This unsigned integer specifies the number of fractional bits that are valid in the [AFBDIV](#page-54-0) value. There are 33 fractional bits in [AFBDIV.](#page-54-0) The value in this AFBBP field specifies 33 – number_of_valid[_AFBDIV_](#page-54-0)fractional_bits. When AFBBP=0 all 33 [AFBDIV](#page-54-0) fractional bits are valid. When AFBBP=9, the most significant 24 [AFBDIV](#page-54-0) fractional bits are valid and the least significant 9 bits must be set to 0. This register field is only used when the feedback divider value is expressed in the form [AFBDIV](#page-54-0) + [AFBREM](#page-57-0) / [AFBDEN.](#page-56-0) AFBBP values greater than 33 are invalid. See section [5.5.4.](#page-13-0)

Bit 7: Decrement Frequency (DECF). When FDSS=000, this bit is the APLL frequency decrement control signal. See section [5.5.7.](#page-16-0)

Bits 6 to 4: Frequency Decrement Source Select (FDSS[2:0]). This field specifies the APLL frequency decrement control signal. Every low-to-high transition and every high-to-low transition of the signal decrements the APLL's output frequency by the amount specified by [AID\[](#page-60-0)23:0] x 2⁷. See section [5.5.7.](#page-16-0)

 $000 = DECF$ bit $001 = GPIOO$ $010 = GPIO1$ $011 = GPIO2$ $100 = GPIO3$ 101 to 111 = ${unused values}$

Bit 3: Increment Frequency (INCF). When FISS=000, this bit is the APLL frequency increment control signal. See section [5.5.7.](#page-16-0)

Bits 2 to 0: Frequency Increment Source Select (FISS[2:0]). This field specifies the APLL frequency increment control signal. Every low-to-high transition and every high-to-low transition of the signal increments the APLL's output frequency by the amount specified by [AID\[](#page-60-0)23:0] x 2⁷. See section [5.5.7.](#page-16-0)

 $000 =$ INCF bit $001 = GPIOO$ $010 = GPIO1$ $011 = GPIO2$ $100 = GPIO3$ 101 to 111 = ${unused values}$

Register Name: ASCR **Register Address:** 116h

Register Description: APLL Spread Spectrum Configuration Register 1

Bits 6 to 5: Count Enable (CNTEN[1:0]). This field can be used to specify a count, or divide, value to divide the APLL feedback divider clock down as needed for clocking the spread-spectrum logic when doing spread-spectrum modulation in the fractional output divider. See section [5.5.8.2.](#page-17-0)

Bit 4: Spread Spectrum Down Only (DWNEN). Spread spectrum frequency modulation can be either centerspread or down-spread. See section [5.5.8.](#page-16-1)

- $0 =$ Center-spread
- 1 = Down-spread

Bit 3: Spread Spectrum Enable (SSEN). When SPRDSS (see below) is set to 000, this bit enables spread spectrum modulation in the APLL. See section [5.5.8.](#page-16-1)

Bits 2 to 0: Spread Spectrum Enable Source Select (SPRDSS[2:0]). This field specifies the APLL spread spectrum enable control signal. See section [5.5.8.](#page-16-1)

 $000 =$ SSEN bit $001 = GPIOO$ $010 = GPIO1$ $011 = GPIO2$ $100 = GPIO3$ 101 to 111 = ${unused values}$

Bits 7 to 0: APLL Spread-Spectrum Count (ASCNT[7:0]). The full 16-bit ASCNT[15:0] register spans this register and [ASCNT2.](#page-59-0) ASCNT is an unsigned integer that specifies the number of cycles of the APLL's input clock that the device increments the output frequency and then the number of cycles that the device decrements the output frequency. See section [5.5.8.](#page-16-1)

Bits 7 to 0: APLL Spread-Spectrum Count (ASCNT[15:8]). See the [ASCNT1](#page-59-1) register description.

Register Name: AID1 **Register Address:** 119h

Register Description: APLL Increment/Decrement Register 1

Bits 7 to 0: APLL Increment/Decrement (AID[7:0]). The full 32-bit AID[31:0] register spans this register through [AID4.](#page-60-1) It is an unsigned integer. There are two uses for this field: frequency increment/decrement, and spread spectrum modulation. The two uses are mutually-exclusive, i.e. only one can be in use at a time.

For frequency increment/decrement, [AID\[](#page-60-0)23:0] \times 2⁷ is added to the APLL's feedback divider value each time the trigger specified by [AIDCR.](#page-58-1)FISS changes state. [AID\[](#page-60-0)23:0] x 2⁷ is subtracted from the APLL's feedback divider value each time the trigger specified by [AIDCR.](#page-58-1)FDSS changes state. [AID\[](#page-60-0)31:24] is ignored for frequency increment/decrement. [ACR1.](#page-51-0)USEFDIV must be set to 0 for this behavior. See section [5.5.7.](#page-16-0)

For spread spectrum modulation, the full 32-bit [AID\[](#page-60-0)31:0] value is subtracted (decremented) and added (incremented) to the zero PPM value every APLL input clock cycle for the number of clock cycles specified by the [ASCNT](#page-59-1) registers. The zero PPM value is the nominal [AFBDIV](#page-54-0) register value (when [ACR1.](#page-51-0)USEFDIV=0) or the nominal fractional output divider value (when [ACR1.](#page-51-0)USEFDIV=1). See section [5.5.8.](#page-16-1)

Bits 7 to 0: APLL Increment/Decrement (AID[15:8]). See the [AID1](#page-60-0) register description.

Bits 7 to 0: APLL Increment/Decrement (AID[23:16]). See the [AID1](#page-60-0) register description.

Register Name: AID4 **Register Description:** APLL Increment/Decrement Register 4 **Register Address:** 11Ch

Bits 7 to 0: APLL Increment/Decrement (AID[31:24]). See the [AID1](#page-60-0) register description.

Register Name: F1CR1 **Register Address:** 140h

Register Description: APLL Fractional Output Divider Control Register 1

Bits 7 to 4: APLL Fractional Output Divider Mode (MODE[3:0]).

0000 = Normal, divider-only operation

0001 = NCO or spread-spectrum operation

Other values reserved

Bits 2 to 0: APLL Fractional Output Divider Write Length (FDL[2:0]). This field indicates the last register to write of the [FDIV](#page-61-0) multiregister field where "last register" is as described in section [6.1.3.](#page-30-0) The number of the last register to write is FDL+1. Changing this field from its default value can be useful in NCO mode to reduce SPI or I2C bus usage when NCO changes only affect the least significant bytes of [FDIV.](#page-61-0)

Bits 7 to 0: Fractional Output Divider Value (FDIV[7:0]). The full 40-bit FDIV[39:0] field spans the [F1DIV1](#page-61-0) through [F1DIV5](#page-62-0) registers. FDIV is an unsigned number with 4 integer bits (FDIV[39:36]) and up to 36 fractional bits. FDIV specifies the fixed-point term of the fractional output divider value. The value FDIV=0 is undefined. Unused least significant bits must be written with 0. See section [5.5.5.](#page-14-0)

Bits 7 to 0: Fractional Output Divider Value (FDIV[15:8]). See the [F1DIV1](#page-61-0) register description.

Bits 7 to 0: Fractional Output Divider Value (FDIV[23:16]). See the [F1DIV1](#page-61-0) register description.

Register Name: F1DIV4
Register Description: APLL Fr **Register Address:**

Register Description: APLL Fractional Output Divider Register 4

Bits 7 to 0: Fractional Output Divider Value (FDIV[31:24]). See the [F1DIV1](#page-61-0) register description.

Bits 7 to 0: Fractional Output Divider Value (FDIV[39:32]). See the [F1DIV1](#page-61-0) register description.

Register Name: F1DEN1 **Register Address:** 146h

Register Description: APLL Fractional Output Divider Denominator Register 1

Bits 7 to 0: Fractional Output Divider Denominator (FDEN[7:0]). The full 32-bit FDEN[31:0] field spans [F1DEN1](#page-63-0) through [F1DEN4](#page-63-1) registers. FDEN is an unsigned integer that specifies the denominator of the fractional output divider value. The value FDEN=0 is undefined. See section [5.5.5.](#page-14-0)

Bits 7 to 0: Fractional Output Divider Denominator (FDEN [15:8]). See the [F1DEN1](#page-63-0) register description.

Bits 7 to 0: Fractional Output Divider Denominator (FDEN [23:16]). See the [F1DEN1](#page-63-0) register description.

Bits 7 to 0: Fractional Output Divider Denominator (FDEN [31:24]). See the [F1DEN1](#page-63-0) register description.

Register Name: F1REM1 **Register Address:** 14Ah

Register Description: APLL Fractional Output Divider Remainder Register 1

Bits 7 to 0: Fractional Output Divider Remainder (FREM[7:0]). The full 32-bit FREM[31:0] field spans [F1REM1](#page-64-0) through [F1REM4](#page-64-1) registers. FREM is an unsigned integer that specifies the remainder of the fractional output divider value. See section [5.5.5.](#page-14-0)

Bits 7 to 0: Fractional Output Divider Remainder (FREM [15:8]). See the [F1REM1](#page-64-0) register description.

Default | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0

Bits 7 to 0: Fractional Output Divider Remainder (FREM [23:16]). See the [F1REM1](#page-64-0) register description.

Bits 7 to 0: Fractional Output Divider Remainder (FREM [31:24]). See the [F1REM1](#page-64-0) register description.

Register Name: F1BP **APLL Fractional Output Divider Truncate Bit Position Register Address:** 14Eh

Bits 5 to 0: APLL Fractional Output Divider Truncate Bit Position (FBP[5:0]). This unsigned integer specifies the number of fractional bits that are valid in the fractional output divider value [\(FDIV\)](#page-61-0). There are 36 fractional bits in [FDIV.](#page-61-0) The value in this FBP field specifies 36 – number_of_valid[_FDIV_](#page-61-0)fractional_bits. When FBP=0 all 36 [FDIV](#page-61-0) fractional bits are valid. When FBP=12, the most significant 24 [FDIV](#page-61-0) fractional bits are valid and the least significant 12 bits must be set to 0. This register field is only used when the feedback divider value is expressed in the form [FDIV](#page-61-0) + [FREM](#page-64-0) / [FDEN.](#page-63-0) FBP values greater than 36 are invalid. See section [5.5.5.](#page-14-0)

6.3.4 Path 2 Configuration Registers

Bit 6: Align Output Dividers (DALIGN). A 0-to-1 transition on this bit causes a simultaneous reset of the medium-speed dividers and the low-speed dividers for all output clocks where [OCxCR1.](#page-67-0)PHEN=1. After this reset all PHEN=1 output clocks with frequencies that are exactly integer multiples of one another will be rising-edge aligned as specified by their [OCxPH](#page-72-1) registers. This bit should be set then cleared once during system startup. Setting this bit during normal system operation can cause phase jumps in the output clock signals.

Bits 5 to 4: External Switch Source Select (EXTSS[1:0]). This field selects the GPIO source for the external switch control signal. It is only valid when [P2CR3.E](#page-66-0)XTSW=1. See section [5.5.1.](#page-12-4)

 $00 = GPIOO$ $01 = GPIO1$ $10 = GPIO2$ $11 = GPIO3$

Register Name: P2CR3 **Register Address:** 182h

Register Description: Path 2 Configuration Register 3

Bit 6: Path 2 External Switching Mode (EXTSW). This bit enables Path 2 external reference switching mode. In this mode, if the selected GPIO signal is low the Path 2 input mux is controlled by [P2CR1.](#page-65-0)MUX. If the selected GPIO signal is high the Path 2 input mux is controlled by [P2CR1.](#page-65-0)ALTMUX. [P2CR1.](#page-65-0)EXTSS specifies which GPIO pin controls this behavior. See section [5.15.](#page-29-0)

Bits 5 to 3: Path 2 Alternate Mux Control (ALTMUX[2:0]). This field specifies the alternate Path 2 clock source for external switching (when EXTSW=1). See section [5.15.](#page-29-0)

 $000 = IC1$ input (default) $001 = IC2$ input $010 = IC3$ input $011 = XA$ input (not doubled) $100-111 = {reserveed values}$

Bits 2 to 0: Path 2 Mux Control (MUX[2:0]). By default this field controls the Path 2 input mux. It also specifies the primary Path 2 clock source for external switching (when EXTSW=1). See section [5.15.](#page-29-0)

 $000 = IC1$ input $001 = IC2$ input $010 = IC3$ input 011 = XA input (not doubled) (default) 100-111 = {reserved values}

6.3.5 Output Clock Configuration Registers

Bit 7: Phase Alignment Enable (PHEN). This bit enables this output to participate in phase alignment. See section [5.6.5.](#page-20-2)

 $0 =$ Phase alignment disabled for this output

1 = Phase alignment enabled for this output

Bits 6 to 0: Medium-Speed Divider Value (MSDIV[6:0]). This field specifies the setting for the output clock's medium-speed divider. The divisor is MSDIV+1. Note that if MSDIV is not set to 0 (bypass) then the maximum input clock frequency to the medium-speed divider is 750MHz and the maximum output clock frequency from the medium-speed divider is 375MHz. When MSDIV=0, the medium-speed divider, phase adjust, low-speed divider, start/stop and output duty cycle adjustment circuits are bypassed and the high-frequency clock signal is sent to the directly output driver. See section [5.6.2.](#page-19-0)

Bit 6: Clock Path Polarity (POL). The clock path to the output driver is inverted when this bit set. This does not invert the LSDIV path to the CMOS OCxN pin if that path is enabled. See section [5.6.1.](#page-18-0)

Bits 5 to 4: CMOS/HSTL Output Drive Strength (DRIVE[1:0]). The CMOS/HSTL output drivers have four equal sections that can be enabled or disabled to achieve four different drive strengths from 1x to 4x. When the output power supply VDDOx is 3.3V or 2.5V, the user should start with 1x and only increase drive strength if the output is highly loaded and signal transition time is unacceptable. When VDDOx is 1.8V or 1.5V the user should start with 4x and only decrease drive strength if the output signal has unacceptable overshoot. See section [5.6.1.](#page-18-0)

- $00 = 1x$ $01 = 2x$
- $10 = 3x$
- $11 = 4x$

Bits 3 to 0: Output Clock Signal Format (OCSF[3:0]). See section [5.6.1.](#page-18-0)

0000 = Disabled (high-impedance, low power mode)

- $0001 = LVDS$ (V_{OD} is forced to 400mV and [OCxDIFF.](#page-68-0) VOD is ignored)
- $0010 =$ Differential (default is LVPECL with V $_{\text{CM}}$ =1.2V, programmable using [OCxDIFF](#page-68-0) fields)
- 0011 = HSTL (set $OCxCR2.DRIVE=11$ (4x) to meet JESD8-6)
- 0100 = Two CMOS: OCxN in phase with OCxP
- 0101 = One CMOS: OCxP enabled, OCxN high impedance
- 0110 = One CMOS: OCxP high impedance, OCxN enabled
- 0111 = Two CMOS: OCxN inverted vs. OCxP
- $1010 = HCSL$

Register Name: OCxDIFF

Register Description: Output Clock x Start Stop Register
 Register Address: OC1: 202h, OC2: 212h, OC3: 222h **Register Address:** OC1: 202h, OC2: 212h, OC3: 222h, OC4: 232h, OC5: 242h OC6: 252h, OC7: 262h, OC8: 272h, OC9: 282h, OC10: 292h

Bits 7 to 4: Differential Common-Mode Voltage (VCM[3:0]). This field specifies the common-mode voltage for the differential output driver. See section [5.6.1.](#page-18-0)

0000 = 1.23V (default) – typical for LVDS and AC-coupled LVPECL

 $0011 = 1.0V$ $0100 = 1.1V$ $0101 = 1.3V$ $0110 = 1.4V$ $0111 = 1.5V$ $1000 = 1.6V$ $1001 = 1.7V$ $1010 = 1.8V$ $1011 = 1.9V$ 1100 = 2.0V – typical for DC-coupled LVPECL $1101 = 2.1V$ 1111 = Use this setting for HCSL signal format All other values reserved

Bits 3 to 0: Differential Swing Voltage (VOD[3:0]). This field specifies the differential output voltage (V_{OD}) for the differential output driver. In the device this field actually controls driver output current. When the specified current is driven into the required external 100 Ω termination resistor, the voltage across the termination resistor is the desired V_{OD}. See [Figure 16](#page-79-0) for the definition of V_{OD}. V_{OD} is equivalent to the single-ended voltage swing of the OCxP pin or the OCxN pin. This field is ignored and V_{OD} is set to 400mV when [OCxCR2.](#page-67-1)OCSF=0001 (LVDS). See section [5.6.1.](#page-18-0)

0000 = 300mV (3mA driver current) $0001 = 400$ mV – typical for LVDS $0010 = 500$ mV $0011 = 600$ mV $0100 = 700$ mV 0101 = 800mV – default value, typical for LVPECL 0110 = 900mV (9mA driver current) 1010 = Use this setting for HCSL signal format

All other values reserved

Register Name: OCxREG

Register Description: Output Clock x Regulator Control Register
 Register Address: OC1: 203h, OC2: 213h, OC3: 223h, OC4: **Register Address:** OC1: 203h, OC2: 213h, OC3: 223h, OC4: 233h, OC5: 243h OC6: 253h, OC7: 263h, OC8: 273h, OC9: 283h, OC10: 293h

Bits 3 to 0: Regulator Voltage (VREG[3:0]). This field specifies the power supply regulator voltage for the differential output driver. Set this to at least VCM+VOD/2+0.5V. Max value is 2.2V when VDDOx is 2.5V, and max value is 2.9V when VDDOx is 3.3V. See section [5.6.1.](#page-18-0)

0000 = 2.2V (default) – typical for LVDS and AC-coupled LVPECL $0010 = 2.0V$ $0011 = 2.2V$ $0100 = 2.25V$ $0101 = 2.4V$ $0111 = 2.5V$ $1000 = 2.7V$ $1001 = 2.75V$ $1010 = 2.8V$ 1011 = 2.9V – typical for DC-coupled LVPECL $1100 = 3.0V$ 1111 = Use this setting for HCSL signal format All other values reserved

Register Name: OCxCR3

Register Description: Output Clock x Configuration Register 3
 Register Address: OC1: 204h, OC2: 214h, OC3: 224h, OC4: **Register Address:** OC1: 204h, OC2: 214h, OC3: 224h, OC4: 234h, OC5: 244h OC6: 254h, OC7: 264h, OC8: 274h, OC9: 284h, OC10: 294h

Bit 7: Enable LSDIV Statuses (SRLSEN). This bit enables the [OCxSR.](#page-50-0)LSCLK real-time status bit and its associated latched status bit [OCxSR.](#page-50-0)LSCLKL.

 $0 =$ LSCLK status bit is not enabled (low)

1 = LSCLK status bit is enabled

Bit 5: OCxN Low Speed Divider (NEGLSD). This bit selects the source of the clock on the OCxN pin in CMOS mode. See section [5.6.2.](#page-19-0)

 $0 =$ Same as OCxP

1 = Output of the LSDIV divider

Note: NEGLSD should only be set to one in two-CMOS mode [\(OCxCR2.](#page-67-1)OCSF=100 or 111), when [OCxCR2.](#page-67-1)POL=0, and when [OCxCR3.](#page-70-0)LSSEL=0.

Bit 4: LSDIV Select (LSSEL). This bit selects the source of the output clock. When the MSDIV divider is selected (LSSEL=0) the LSDIV divider output can be independently selected as the source for the OCxN pin (in CMOS output mode) or monitored by the [OCxSR.](#page-50-0)LSCLK status bit. This bit is only valid when $OCxCR1.MSDIV > 0$. See section [5.6.2.](#page-19-0)

 $0 =$ The output clock is sourced from the MSDIV divider.

1 = The output clock is sourced from the LSDIV divider.

Bit 2: Auto-Squelch Enable (ASQUEL). This bit enables automatic squelching of the output clock whenever (a) automatic input switching is enabled for the APLL, and (b) the input monitors indicate that the inputs specified by the APLL's APLLMUX and ALTMUX fields are both invalid. [OCxSTOP.](#page-72-0)MODE specifies the type of stop (high, low, high-impedance) and the output clock edge on which to stop. When a differential output or a CMOS complementary output is squelched, its OCxN pin is opposite polarity of its OCxP pin.

- $0 =$ Auto-squelch disabled
- $1 =$ Auto-squelch enabled

Bit 0: Low-Speed Divider Value (LSDIV[24]). See the [OCxDIV1](#page-71-0) register description.

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Register Name: OCxDIV1

Register Description: Output Clock x Divider Register 1
 Register Address: OC1: 205h, OC2: 215h, OC3: 225 **Register Address:** OC1: 205h, OC2: 215h, OC3: 225h, OC4: 235h, OC5: 245h OC6: 255h, OC7: 265h, OC8: 275h, OC9: 285h, OC10: 295h

Bits 7 to 0: Low-Speed Divider Value (LSDIV[7:0]). The full 25-bit LSDIV[24:0] field spans this register, [OCxDIV2,](#page-71-1) [OCxDIV3.](#page-71-2) and bit 0 of [OCxCR3.](#page-70-0) LSDIV is an unsigned integer. The frequency of the clock from the medium-speed divider is divided by LSDIV+1. The [OCxCR3.](#page-70-0)LSSEL and NEGLSD bits control when the output of the low-speed divider is present on the OCxP and OCxN output pins. [OCxCR1.](#page-67-0)MSDIV must be > 0 for the low-speed divider to operate. See section [5.6.2.](#page-19-0)

Bits 7 to 0: Low-Speed Divider Value (LSDIV[15:8]). See the [OCxDIV1](#page-71-0) register description.

Bits 7 to 0: Low-Speed Divider Value (LSDIV[23:16]). See the [OCxDIV1](#page-71-0) register description.

Bits 7 to 0: Output Clock Duty Cycle (OCDC[7:0]). This field controls the output clock signal duty cycle when MSDIV>0 and LSDIV>1. When OCDC = 0 the output clock is 50%. Otherwise the clock signal is a pulse with a width of OCDC number of MSDIV output clock periods. The range of OCDC can create pulse widths from 1 to 255 MSDIV output clock periods. When [OCxCR2.](#page-67-1)POL=0, the pulse is high and the signal is low the remainder of the cycle. When POL=1, the pulse is low and the signal is high the remainder of the cycle. See section [5.6.3.](#page-20-3)

Register Name: OCxPH

Register Description: Output Clock x Phase Adjust Register
 Register Address: OC1: 209h, OC2: 219h, OC3: 229h, O **Register Address:** OC1: 209h, OC2: 219h, OC3: 229h, OC4: 239h, OC5: 249h OC6: 259h, OC7: 269h, OC8: 279h, OC9: 289h, OC10: 299h

Bits 3 to 0: Phase Adjust Value (PHADJ[3:0]). This field can be used to adjust the phase of an output clock vs. the phase of other clock outputs. The adjustment is in units of bank source clock cycles. For example, if the bank source clock is 625MHz (from the APLL for example) then one bank source clock cycle is 1.6ns, the smallest phase adjustment is 0.8ns, and the adjustment range is ±5.6ns. Negative values mean earlier in time (leading) and positive values mean later in time (lagging). See section [5.6.4.](#page-20-0)

Bits 6 to 3: Output Clock Stop Source (SRC[3:0]). This field specifies the source of the stop signal. See section [5.6.7.](#page-20-1)

 $0000 =$ Never stop 0001 = Logical OR of (the global [MCR1.](#page-35-0)STOP bit) or (the OCx stop bit in the [STOPCR](#page-39-0) registers) 0010 to 0111 = ${unused values}$ $1000 = GPIO0$ $1001 = GPIO1$ $1010 = GPIO2$ $1011 = GPIO3$ 1100 to $1111 = \{$ unused values $\}$

Bit 2: NEGLSD Stop Behavior (NEGLSD). When an output pair is configured for two different frequencies in 2xCMOS mode (see section [5.6.2\)](#page-19-0) this bit specifies the stop behavior for the pair. This field allows the user to trade off stop reaction time vs. possible short pulse on the NEG pin.

 $0 =$ Stop when higher-speed POS signal has the appropriate edge (see MODE field below)

1 = Stop when lower-speed NEG signal has the appropriate edge.

Setting this bit to 1 guarantees no short high/low time for the POS signal and for the NEG signal, but stopping can take a long time when the NEG pin is very low frequency, such as 2kHz or even 1Hz.

Setting this bit to 0 allows stopping to happen faster because it depends only on the frequency of the POS signal, but the NEG signal may have a short high or low time when it stops. For some applications, such as when NEG is

a 1 pulse per second (PPS) signal, a short high or low time when NEG stops may not matter because NEG is essentially a data signal (phase alignment or time alignment signal that is latched by a POS signal edge) rather than a true clock signal.

Bits 1 to 0: Output Clock Stop Mode (MODE[1:0]). This field selects the mode of the start-stop function. See section [5.6.6.](#page-20-2)

00 = Stop Low: stop after falling edge of output clock, start after rising edge of output clock

01 = Stop High: stop after rising edge of output clock, start after falling edge of output clock

10 = Stop Low then go high-impedance: stop after falling edge, start after rising edge

11 = Stop High then go high-impedance: stop after rising edge, start after falling edge

The following table shows which pin(s) stop high or low as specified above for each output signal format:

6.3.6 Input Clock Configuration Registers

Bit 6: Input Polarity (POL). This field specifies which input clock edge the APLL will lock to. See section [5.5.1.](#page-12-0)

 $0 =$ Rising edge

 $1 =$ Falling edge

Bit 5: Disable Signal Going to the Monitor (DISMON).

 $0 = XA$ signal is provided to the XA monitor

 $1 = XA$ signal is not provided to the XA monitor

Bits 4 to 2: Input Validation Time (VALTIME[2:0]). The input clock monitor only declares the XA input clock valid if it has no missing edges in the interval specified by this field. See section [5.5.2.](#page-12-1)

 $000 = 1$ cycle $001 = 4$ cycles $010 = 16$ cycles $011 = 64$ cycles $100 = 256$ cycles $101 = 1024$ cycles 110 - 111 = ${unused values}$

Bits 1 to 0: Input Clock High-Speed Divider (HSDIV[1:0]). This field specifies the divide value for the XA input clock divider. This field should not be set to 01 at the same time [MCR2.](#page-36-0)DBL=1. See section [5.5.1.](#page-12-0)

- $00 = Divide$ by 1
- $01 = Divide$ by 2
- 10, 11 = ${unused values}$

Bits 7 to 0: XO Amplifier Control (XOAMP[7:0]). Set this value as follows for the recommended 10pF crystal (values in decimal). Contact Microsemi apps support for XOAMP values for crystals with other load capacitances.

Register Name: XACR3 **Register Address:** 302h

Register Description: XA Input Clock Configuration Register 3

Bits 7 to 4: XB Internal Capacitor Selection (XBCAP[3:0]). Actual internal capacitance on the XB pin in pF is approximately 6 + XBCAP. See section [5.3.2.](#page-10-0)

Bits 3 to 0: XA Internal Capacitor Selection (XACAP[3:0]). Actual internal capacitance on the XA pin in pF is approximately 6 + XACAP. See section [5.3.2.](#page-10-0)

Bit 6: Input Polarity (POL). This field specifies which input clock edge the APLL will lock to. See section [5.5.1.](#page-12-0)

 $0 =$ Rising edge

 $1 =$ Falling edge

Bit 5: Disable Signal Going to the Monitor (DISMON).

 $0 = ICx$ signal is provided to the ICx monitor

 $1 =$ ICx signal is not provided to the ICx monitor

Bits 4 to 2: Input Validation Time (VALTIME[2:0]). The input clock monitor only declares the input clock valid if it has no missing edges in the interval specified by this field. See section [5.5.2.](#page-12-1)

 $000 = 1$ cycle $001 = 4$ cycles $010 = 16$ cycles $011 = 64$ cycles $100 = 256$ cycles $101 = 1024$ cycles 110 - 111 = ${unused values}$

Bits 1 to 0: Input Clock High-Speed Divider (HSDIV[1:0]). This field specifies the divide value for the input clock high-speed divider. See section [5.5.1.](#page-12-0)

 $00 = Divide$ by 1 $01 = Divide$ by 2

- $10 = Divide$ by 4
- $11 = Divide$ by 8

7. Electrical Characteristics

Absolute Maximum Ratings

* Exceeding these values may cause permanent damage. Functional operation under these conditions is not implied.

* Voltages are with respect to ground (VSS) unless otherwise stated.

Note 1: The typical values listed in the tables of Section [7](#page-76-0) are not production tested.

Note 2: Specifications to -40°C and 85°C are guaranteed by design or characterization and not production tested.

Table 5 - Recommended DC Operating Conditions

Table 6 - Electrical Characteristics: Supply Currents

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Note 1: Typical values measured at nominal supply voltages and 25°C ambient temperature.

Note 2: Max I_{DD} measurements made with all blocks enabled, 650MHz signals on IC1 and IC2 inputs, 187.5MHz signal on IC3, Crystal driver and doubler off , VCO frequency of 3750MHz, APLL output dividers dividing by 6, all MSDIV dividing by 2, all LSDIV dividing by 2, all outputs enabled as LVPECL outputs driving 156.25MHz signals, and all VDDO at same voltage as VDDH. Typical I_{DD} measurements made with same setup as max I_{DD} but APLL fractional dividers disabled and only six outputs enabled with LVDS signal format.

- **Note 3:** VDDOx=3.3V, 1x drive strength, f₀=250MHz, 2pF load
- **Note 4:** VDDOx=1.8V, 2x drive strength, f_0 =100MHz, 100 Ω differential termination.
- **Note 5:** 50Ω to ground each on OCxP and OCxN.

Table 7 - Electrical Characteristics: Non-Clock CMOS Pins

Note 1: 0V < V_{IN} < VDDIO for all other non-clock inputs.

Note 2: V_{OH} does not apply for SCL and SDA in I²C interface mode since they are open drain.

Note 3: To output a clock on a GPIO pin, an OCx output must be configured with NEGLSD=1 and SRLSEN=1 in [OCxCR3](#page-70-0) and the GPIO must be configured to as a status output followin[g OCxSR.](#page-50-0)LSCLK (see the [GPIOCR](#page-40-0) and [GPIOxSS](#page-41-0) registers). Output jitter is not guaranteed for clock signals on GPIO pins but is typically 1 to 5ps rms 12kHz to 20MHz.

Note 4: 20%-80%, 15pF load.

Table 8 - Electrical Characteristics: XA Clock Input

Note 1: 1.0V threshold. See sectio[n 5.3.3](#page-11-0) for duty cycle restrictions when using the XA doubler with low input frequencies.

Table 9 - Electrical Characteristics: Clock Inputs, ICxP/N

- Note 1: The device can tolerate voltages as specified in V_{TOL} w.r.t. VSS on its ICxP and ICxN pins without being damaged. For differential input signals, proper operation of the input circuitry is only guaranteed when the other specifications in this table, including V_{ID} , are met.
- Note 2: For inputs IC1P/N and IC2P/N V_{ID}=|V_{ICxP} V_{ICxN}|. For input IC3P, V_{ID}=|V_{IC3P} V_{CMI}|. The max V_{ID} spec only applies when a differential signal is applied on ICxP/N; it does not apply when a single-ended signal is applied on ICxP.
- **Note 3: Differential signals.** The differential inputs can easily be interfaced to neighboring ICs driving LVDS, LVPECL, CML, HCSL, HSTL or other differential signal formats using a few external passive components. In general, Microsemi recommends terminating the signal with the termination/load recommended in the neighboring component's data sheet and then AC-coupling the signal into the ICxP/ICxN pins. See [Figure 15](#page-79-0) for details. To connect a differential signal to IC3, AC-couple one side of the signal to IC3P and AC-couple the other side to VSS. For DC-coupling, treat the input as 1.8V CML.
- **Note 4: Single-ended signals** can be connected to the ICxP pins. Signals with amplitude greater than 2.5V must be DC-coupled. For signals with amplitudes less than 2.5V Microsemi recommends AC-coupling but DC-coupling can also be used. When a singleended signal is connected to ICxP, ICxN should be connected to a capacitor $(0.1 \mu F$ or $0.01 \mu F)$ to VSS.

Figure 14 - Electrical Characteristics: Clock Inputs

Figure 15 - Example External Components for Differential Input Signals

Note 1: [OCxCR2.O](#page-67-0)CSF=0001 (LVDS). Output must have 100Ω DC path between OUTxP and OUTxN to meet these V_{OD} specs. See [Figure 17](#page-81-0) parts a) and b) for examples where this DC path is a 100 Ω termination resistor at the receiver.

Table 11 - Electrical Characteristics: LVPECL Clock Outputs

VDDOx=VDDH=3.3V±5% or VDDOx=VDDH=2.5V±5% for LVPECL operation.

Note 1: [OCxCR2.O](#page-67-0)CSF=0010, [OCxDIFF.](#page-68-0)VCM=1100, [OCxDIFF.V](#page-68-0)OD=0101. Output must have 100Ω DC path between OUTxP and OUTxN to meet these V_{OD} specs. See [Figure 17](#page-81-0) parts a) and b) for examples where this DC path is a 100 Ω termination resistor at the receiver.

Table 12 - Electrical Characteristics: HCSL Clock Outputs $V = V D D H = 3.3V + 50/25$

Note 1: Each of OCxP and OCxN with 50Ω termination resistor to ground.

Table 13 - Electrical Characteristics: CMOS and HSTL (Class I) Clock Outputs

Note 1: Minimum output frequency is a function of VCO frequency and output divider values and is guaranteed by design.

Note 2: For HSTL Class I, V_{OH} and V_{OL} apply for both unterminated loads and for symmetrically terminated loads, i.e. 50 Ω to VDDOx/2.

Note 3: For VDDOx=3.3V an[d OCxCR2.](#page-67-0)DRIVE=1x, I_O=4mA. For VDDOx=1.5V and [OCxCR2.](#page-67-0)DRIVE=4x, I_O=8mA.

Note 4: Output clock frequency ≤ 160MHz or VDDOx ≥ 1.8V.

Note 5: Output clock frequency > 160MHz and VDDOx < 1.8V.

Note 6: Measured differentially.

Figure 17 - Example External Components for Output Signals

[Figure 17](#page-81-0) part c) covers the case where an existing receiver has AC coupling caps followed by an internal or external 100 Ω termination resistor. The driver requires a DC path between its POS and NEG pins even in this case. A 200 Ω resistor is recommended. Since this arrangement attenuates the signal by one third, The [OCxDIFF.V](#page-68-0)OD field should be set 50% higher to compensate.

Table 14 - Electrical Characteristics: APLL Frequencies

Table 15 - Electrical Characteristics: Jitter and Skew Specifications

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Note 1: Jitter calculated from integrated phase noise from 12kHz to 20MHz. Phase jitter includes spurs (if present). Random jitter does not include spurs.

Note 2: Jitter calculated from integrated phase noise from 1.875MHz to 20MHz.

Note 3: With 50MHz crystal doubled as APLL input, APLL VCO frequency 3750MHz, divide by 6 using APLL integer divider, then divide by 4 in output medium-speed divider..

Note 4: Requires phase alignment capability described in sectio[n 5.6.5.](#page-20-3) Only applies for outputs that have the same signal format, VDDO voltage. drive strength and loading/termination. Also, this skew spec doesn't apply to OCxN when an output pair is configured wit[h OCxCR3.N](#page-70-0)EGLSD=1; in this configuration OCxN lags OCxP by up to 1ns.

- **Note 5:** Total Jitter = Deterministic Jitter + 14 x Random Jitter.
- **Note 6:** With 50MHz crystal doubled as APLL input. All output clocks 100MHz HCSL format. Jitter is from the PCIe jitter filter combination that produces the highest jitter.
- **Note 7:** Output frequencies 25MHz. Tested at 156.25MHz.

Note 8: With 50MHz crystal doubled as APLL input. Integer divisor case tested with APLL VCO frequency 3750MHz. Fractional divisor case tested with VCO frequency 3993.6MHz. PCI Express 3.0 and 4.0 case tested with APLL VCO frequency 3750MHz.

Note 9: With 50MHz crystal doubled as APLL input and APLL VCO frequency 3993.6MHz. All output clocks 100MHz HCSL format. Jitter is from the PCIe jitter filter combination that produces the highest jitter. Applies (a) when spread spectrum modulation is disabled and (b) when spread spectrum modulation in the fractional output divider is 0.25% downspread modulated at 31.5kHz.

- **Note 11:** N=10000
- **Note 12:** [AFBDL.F](#page-53-0)BSEL=11. Tested with 125MHz into IC1, APLL VCO frequency of 3750MHz, APLL integer divider set to 5, OCx medium-speed dividers set to 6, OCx 125MHz output frequency. Only applies for outputs that have the same signal format, output divider usage, VDDO voltage, drive strength and load/termination. Also, this delay spec doesn't apply to OCxN when an output pair is configured with [OCxCR3.](#page-70-0)NEGLSD=1; in this configuration OCxN lags OCxP by up to 1ns.

Table 16 - Electrical Characteristics: Typical Output Phase Jitter from the APLL Integer Divider

Note 1: APLL locked to external 125MHz XO (Vectron VCC1-1535-125M000).

Note 2: APLL locked to external 50MHz crystal (TXC 7M50070021), internal doubler enabled when multiplication is fractional.

Note 3: All signals are differential unless otherwise stated. Jitter is integrated 12kHz to 5MHz for 25MHz output frequency and 12kHz to 20MHz for all other output frequencies.

Note 10: Measured using Tektronix MSO71604C, Mixed Signal Oscilloscope with DPOJET software. Measured with 3750MHz VCO frequency, 200MHz out of the fractional divider, and 100MHz out of the medium-speed divider.

Table 17 - Electrical Characteristics: Clock Buffer (APLL Bypass Path and Path 2)

Note 1: APLL bypass enabled, input frequency = output frequency, LVPECL output signal format.

Note 2: Only applies for outputs that have the same signal format, VDDO voltage, drive strength and load/termination. Also, this skew spec doesn't apply to OCxN when an output pair is configured wit[h OCxCR3N](#page-70-0)EGLSD=1; in this configuration OCxN lags OCxP by up to 1ns.

- **Note 3:** Differential outputs with 100Ω differential termination (LVDS, LVPECL, Programmable Differential).
- **Note 4:** CMOS/HSTL outputs, 5pF load.
- **Note 5:** Jitter calculated from integrated phase noise from 12kHz to 20MHz.
- **Note 6:** Tested with 50MHz crystal TXC 7M50070021.
- **Note 7:** Additive jitter contributes in a root-of-sum-of-squares manner. For example, a 156.25MHz input signal with 220fs of jitter will experience typical additive jitter of 155fs in the device, and the resulting output jitter will be sqrt(220²+155²)=269fs.

Table 18 - Electrical Characteristics: Typical Input-to-Output Clock Delay Through APLL

Table 19 - Electrical Characteristics: SPI Slave Interface Timing, Device Registers

 $VDDIO = 3.3V±5%$ or 2.5V±5% or 1.8V±5%

Note 1: All timing is specified with 100pF load on all SPI pins.

Note 2: All parameters in this table are guaranteed by design or characterization.

Note 3: See timing diagram in [Figure 18.](#page-84-0)

Figure 18 - SPI Slave Interface Timing

Table 20 - Electrical Characteristics: SPI Slave Interface Timing, Internal EEPROM

(ZL30261 and ZL30263 Only)

Note 1: This timing applies (a) whe[n EESEL=](#page-33-0)1 and (b) in direct EEPROM write mode (see section [5.11.2\)](#page-28-0).

Note 2: All timing is specified with 100pF load on all SPI pins.

Note 3: All parameters in this table are guaranteed by design or characterization.

Note 4: See timing diagram in [Figure 18.](#page-84-0)

Table 21 - Electrical Characteristics: SPI Master Interface Timing (ZL30260 and ZL30262 Only)

Note 1: All timing is specified with 100pF load on all SPI pins.

Note 2: All parameters in this table are guaranteed by design or characterization.

Note 3: See timing diagram in [Figure 19.](#page-86-0)

Figure 19 - SPI Master Interface Timing

Table 22 - Electrical Characteristics: I²C Slave Interface Timing

Note 1: The timing parameters in this table are specifically for 400kbps Fast Mode. Fast Mode devices are downward-compatible with 100kbps Standard Mode I ²C bus timing. All parameters in this table are guaranteed by design or characterization. All values referred to V_{Hmin} and V_{ILmax} levels (se[e Table 7\)](#page-77-0).

Note 2: The device internally provides a hold time of at least 300ns for the SDA signal (referred to the V_{IHmin} of the SCL signal) to bridge the undefined region of the falling edge of SCL. Other devices must provide this hold time as well per the I²C specification.

Note 3: The I²C specification indicates that the maximum t_{HD:DAT} spec only has to be met if the device does not stretch the low period (t_{LOW}) of the SCL signal. The device does not stretch the low period of the SCL signal.

Note 4: Determined by choice of pull-up resistor.

Figure 20 - I ²C Slave Interface Timing

8. Package and Thermal Information

Table 23 - 8x8mm QFN Package Thermal Properties

Note 1: Theta-JA (θ_{JA}) is the thermal resistance from junction to ambient when the package is mounted on an 8-layer JEDEC standard test board and dissipating maximum power.

Note 2: Theta-JP (θ_{JP}) is the thermal resistance from junction to the center exposed pad on the bottom of the package.

Note 3: For all numbers in the table, the exposed pad is connected to the ground plane with a 9x9 array of thermal vias; via diameter 0.33mm; via pitch 0.76mm.

9. Mechanical Drawing

10.Acronyms and Abbreviations

11. Data Sheet Revision History

